

# EFT methodology – a general introduction –

Ecole de Gif 2023 -- Annecy  
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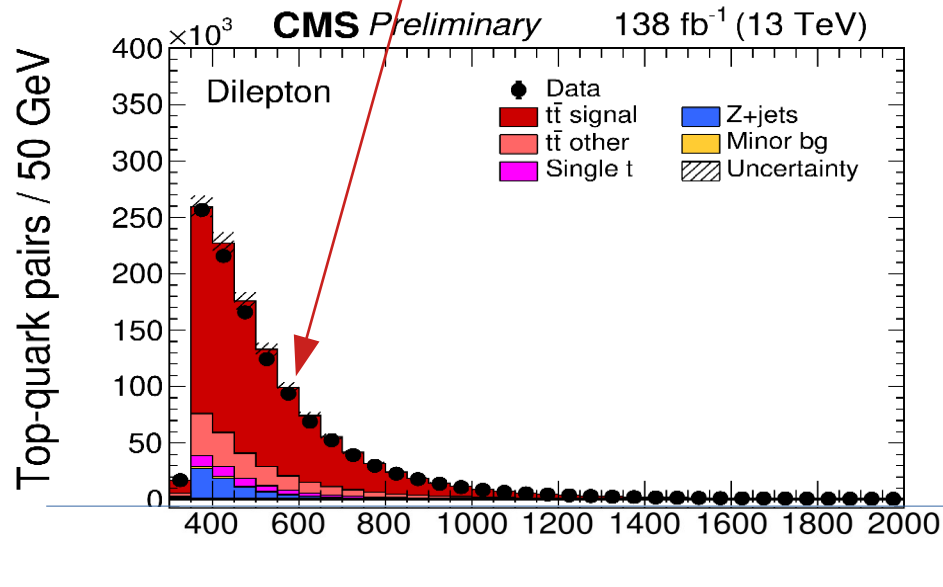
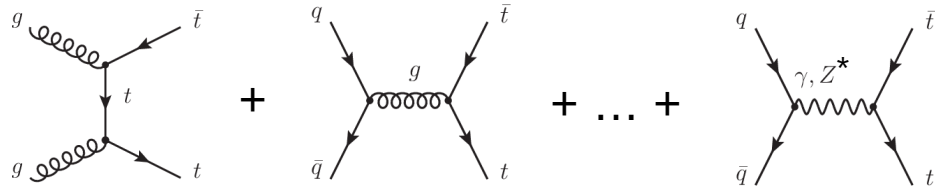
# Introduction

- Standard Model (SM): good description of elementary particles and their interactions (at “low” energy scale)
- Long history of discovering it’s particles & interactions, measuring free parameters and probe its predictions
  - ◆ So far, good agreement in most measurements, but we know that new physics is needed to explain some observations (neutrino masses, dark matter,... )
  - ◆ Continue searching for hints: searching for new particles, new interactions and deviations
  - ◆ Start looking into more and more extreme corners of phase space and tails of distributions
- Maybe new physics is (for now) beyond our reach for direct observation
  - ◆ Still could leave some measurable trace in our observations → should look at very small deviations in a systematic way, combining information from many measurements
  - ◆ Avoid looking at many different models (maybe the right one is not even in the list!) → need a way to interpret measurements in generic (model independent) way to hopefully get a hint where to look

# Example: $t\bar{t}$ production at the LHC

$t\bar{t}$  production at LHC:

SM

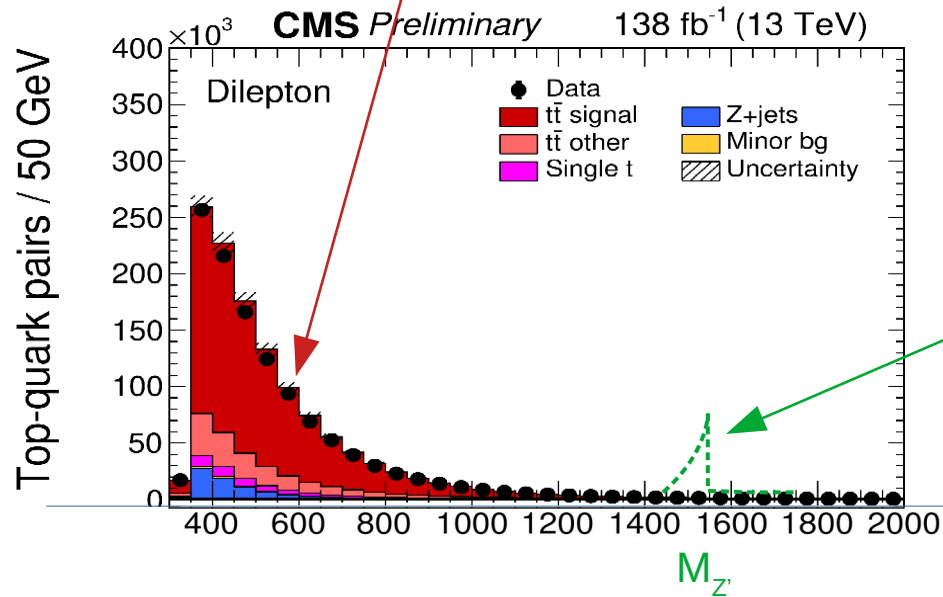
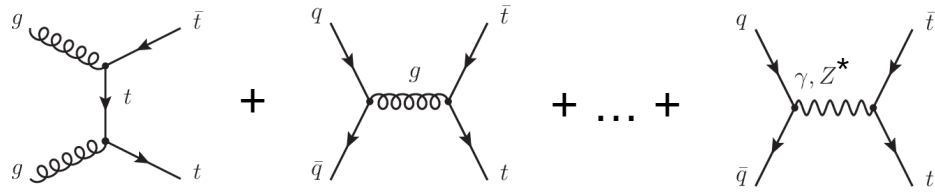


$m(t\bar{t})$  [GeV]

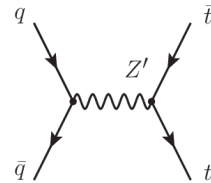
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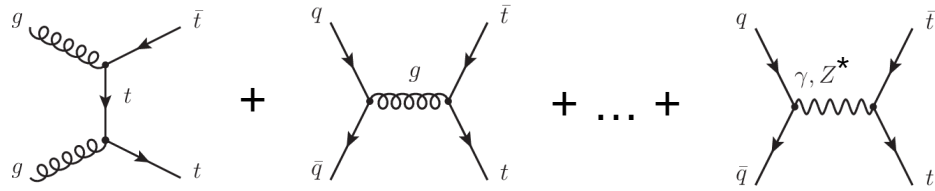
Resonant BSM production



# Example: $t\bar{t}$ production at the LHC

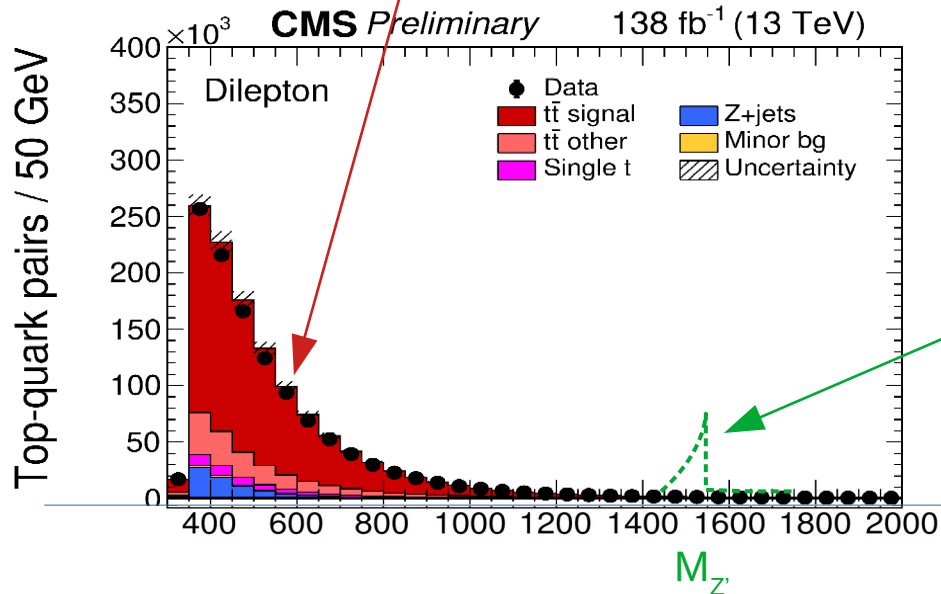
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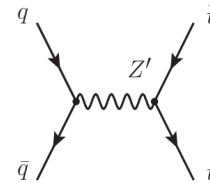


We did not find it (yet); possible reasons

- it does not exist
- it couples very weakly to SM particles
- it is too heavy to be produced at LHC



Resonant BSM production

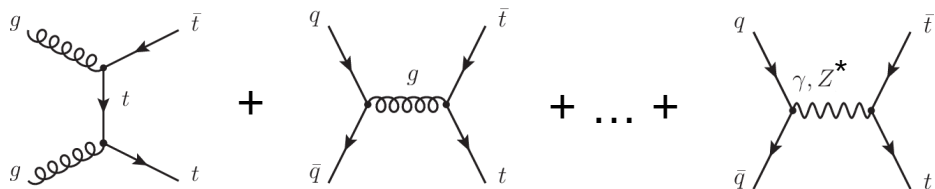


$m(t\bar{t})$  [GeV]

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$t\bar{t}$  production at LHC:

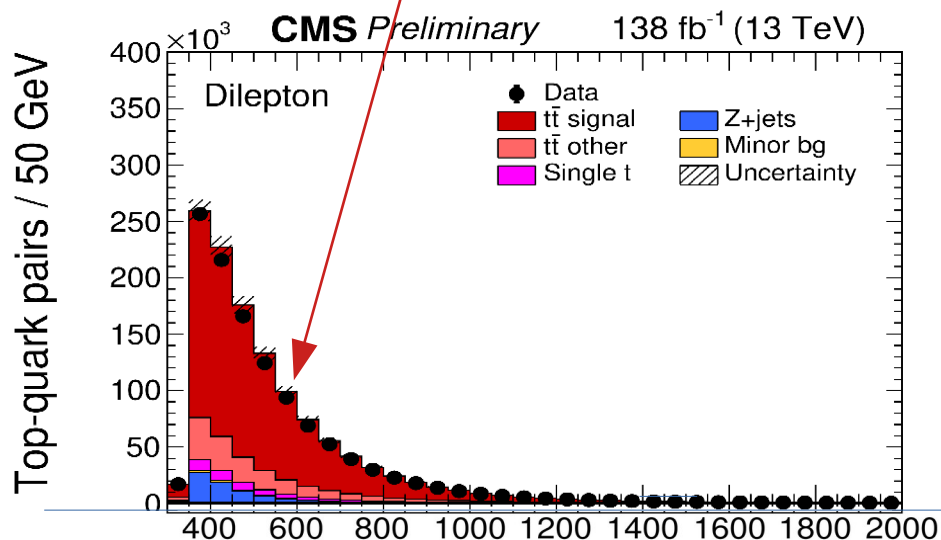
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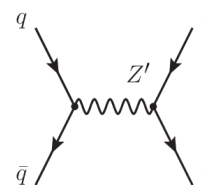
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Let's assume...



Resonant BSM production



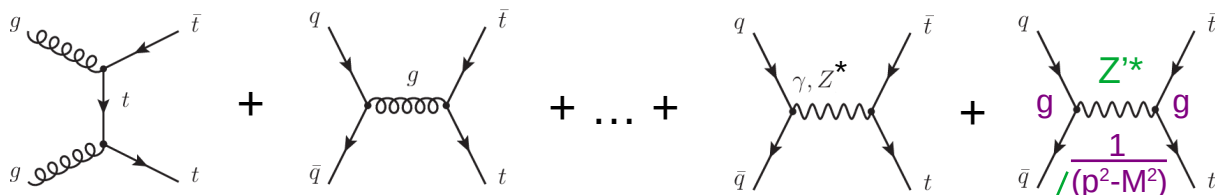
$M_{Z'}$

$m(t\bar{t})$  [GeV]

# Example: ttbar production at the LHC

ttbar production at LHC:

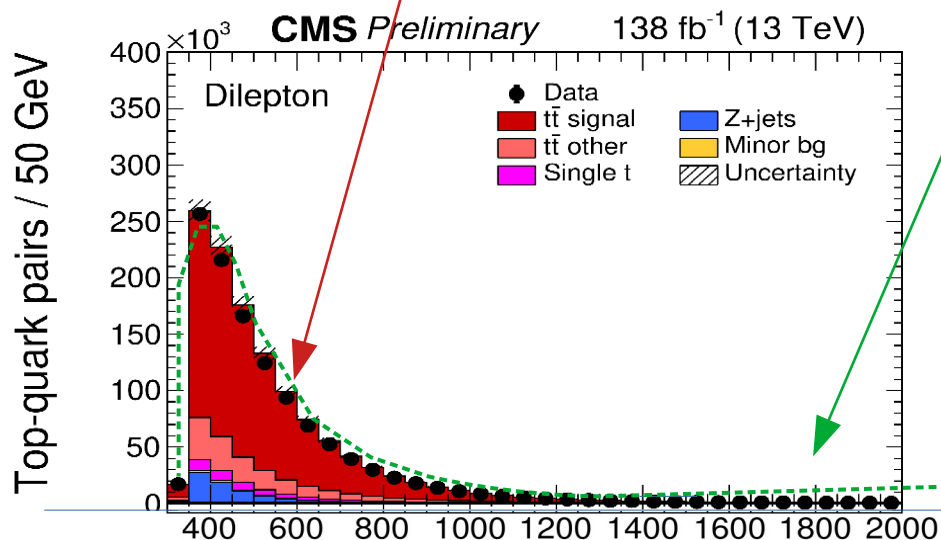
SM



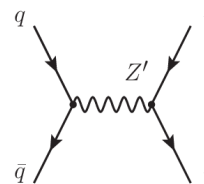
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Resonant BSM production



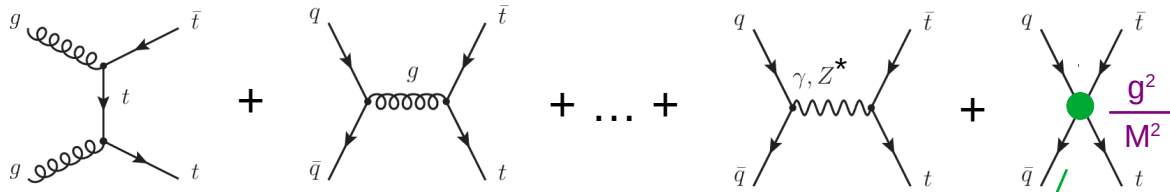
$M_{Z'}$

$m(tt)$  [GeV]

# Example: ttbar production at the LHC

ttbar production at LHC:

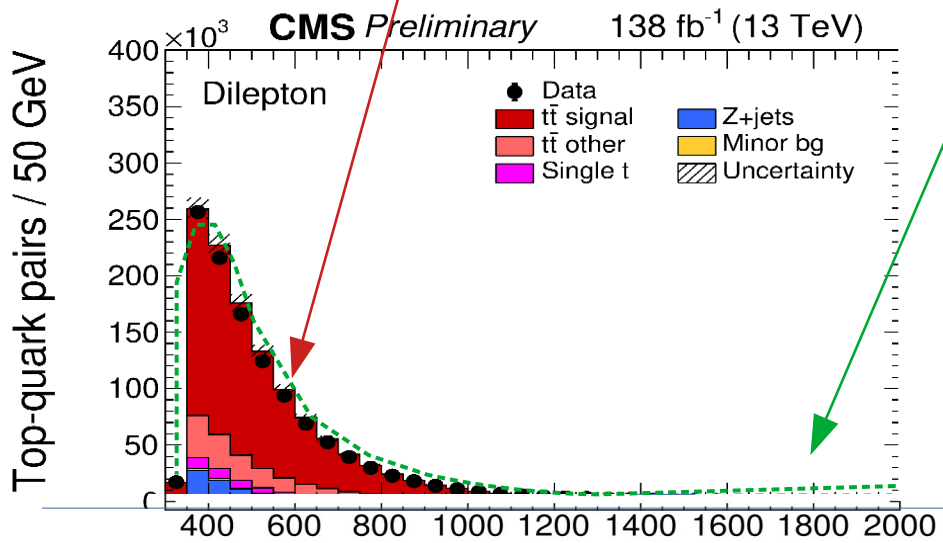
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Let's assume...



- Observe effective coupling that could be explained by many models
- CAVEAT: still assuming here that this is the only modified coupling in this process!

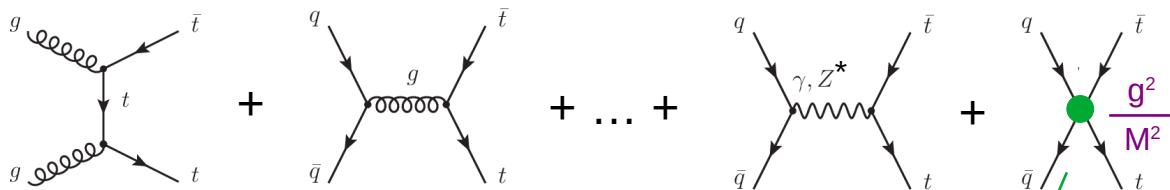
$m(t\bar{t})$  [GeV]



# Example: ttbar production at the LHC

ttbar production at LHC:

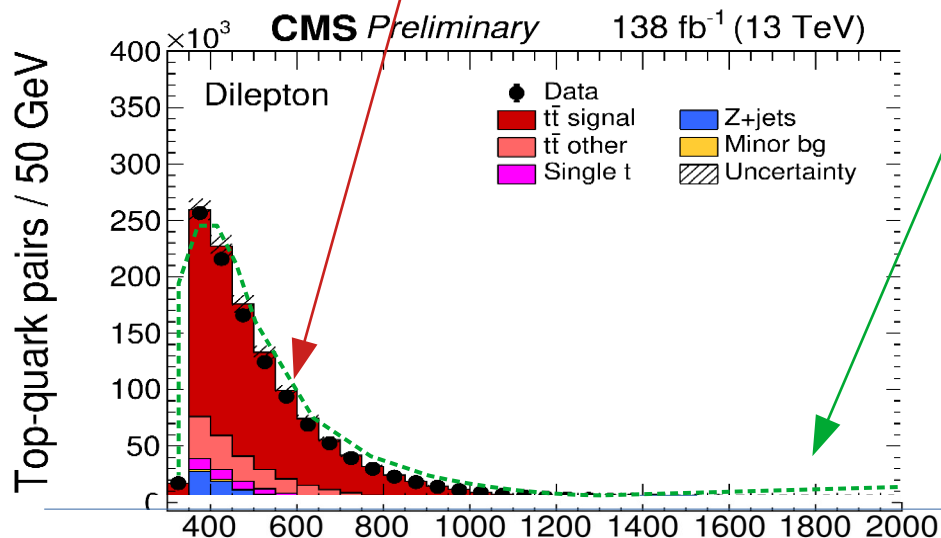
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Let's assume...



Let's generalise & formalise this!  
 → Effective Field Theory (EFT)  
 (theory details in Nazila's lecture)

$m(t\bar{t})$  [GeV]

# Content

- Ingredients for EFT fits
  - ❖ Input measurements – experiments, observables, etc.
- EFT constraints from experimental data
  - ❖ Setup: model, basis, input parameters, symmetries
  - ❖ EFT in the analysis: simulation and parametrisation
  - ❖ Working with a real detector
  - ❖ Validity considerations and theory uncertainties: limitations and work arounds
- Global EFT fits
  - ❖ Benefits and challenges of combined fit
  - ❖ Limitations and perspectives for EFT fits – towards HL-LHC and beyond

Note: This lecture is quite technical; more details on application of these concepts in dedicated sessions (EFT in Higgs + EW and in flavour physics)

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# EFT in 2 sentences

- › EFT is “just” an approximation of a theory at a given energy scale, allowing to “integrate out” contributions from higher scales – we are using it all the time
  - ♦ example 1: QED is an effective theory integrating out everything but photon and electron
  - ♦ example 2: Heavy Quark Effective Theory (HQET) assumes infinite b- and top mass to model B decays
- › If BSM scale is significantly higher than measured energy scale at experiment, the Lagrangian can be expanded:

$$\mathcal{L}_{\text{EFT}} = \mathcal{L}_{\mathcal{D} \leq 4} + \frac{\mathcal{L}_5}{\Lambda} + \frac{\mathcal{L}_6}{\Lambda^2} + \dots$$

- ›  $\mathcal{L}_{\mathcal{D}}$  are linear combinations of all dim-D operators within a set of assumptions -- this allows for a relatively easy interpretation

# EFT in HEP in 2 sentences

- EFT used to constrain BSM at high energy scales in many experiments
  - ◆ Requirement:  $c/\Lambda \ll 1$  – probed BSM scale much higher than experimental scale ( $\sim q^2$ ), i.e. probing BSM via indirect loop effects (e.g. at B-factories, LHC, ... )
  - ◆ Sensitive BSM scale probed with EFT depends on experiment – possibility to match EFT results with direct searches for BSM (e.g. constraints from B decays with searches at the LHC)
- Will concentrate on accelerator based particle physics

	Intensity frontier	Energy frontier
Main characteristics	<ul style="list-style-type: none"><li>• Medium energies, clean environment, high intensity (i.e. large integrated lumi)</li><li>• High precision measurements with indirect probe of BSM</li><li>• Example: Belle 2</li></ul>	<ul style="list-style-type: none"><li>• High center of mass energies</li><li>• Usually hadrons → dirty environment</li><li>• Direct search of BSM, still possible to make precision measurements</li><li>• Example: LHC experiments</li></ul>
Measurements for EFT interpretation	Rare B decays, differential cross sections	(Differential) cross sections of Higgs production, rare SM processes, top quark production, etc.

# Typical analysis workflow

**Experimental data**

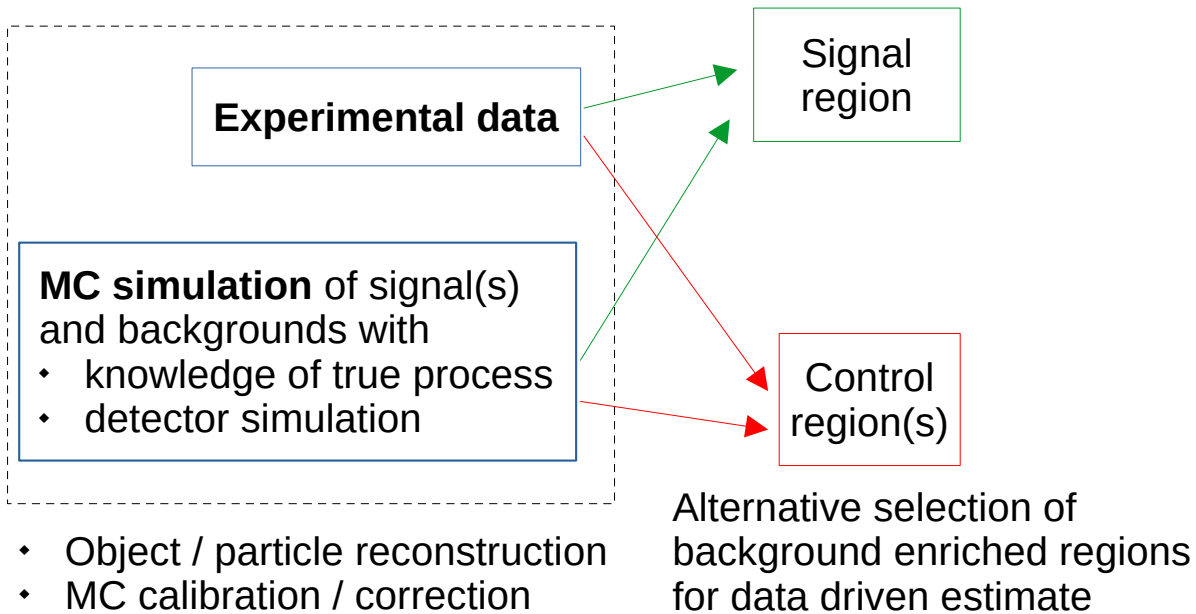
**MC simulation** of signal(s)  
and backgrounds with

- knowledge of true process
- detector simulation

- Object / particle reconstruction
- MC calibration / correction

# Typical analysis workflow

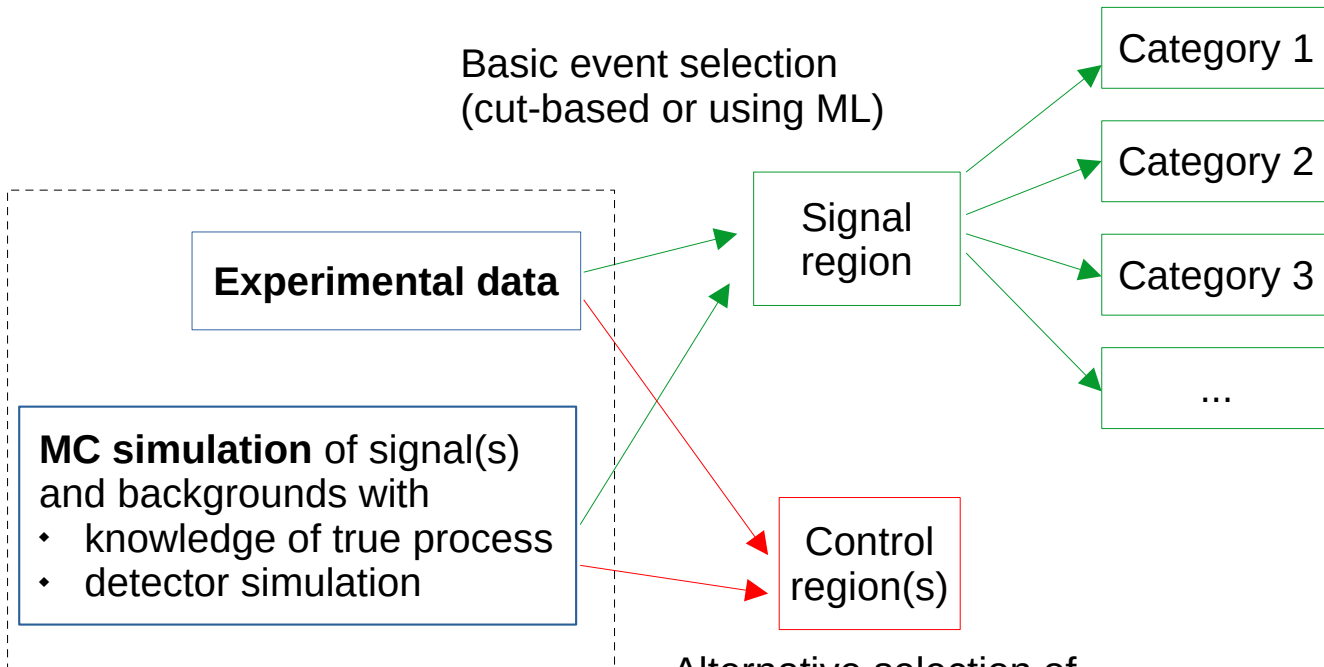
Basic event selection  
(cut-based or using ML)



# Typical analysis workflow

Event categorisation to:

- Split experimental signatures
- Def. regions with good signal significance or resolution
- Target different POIs



Alternative selection of background enriched regions for data driven estimate

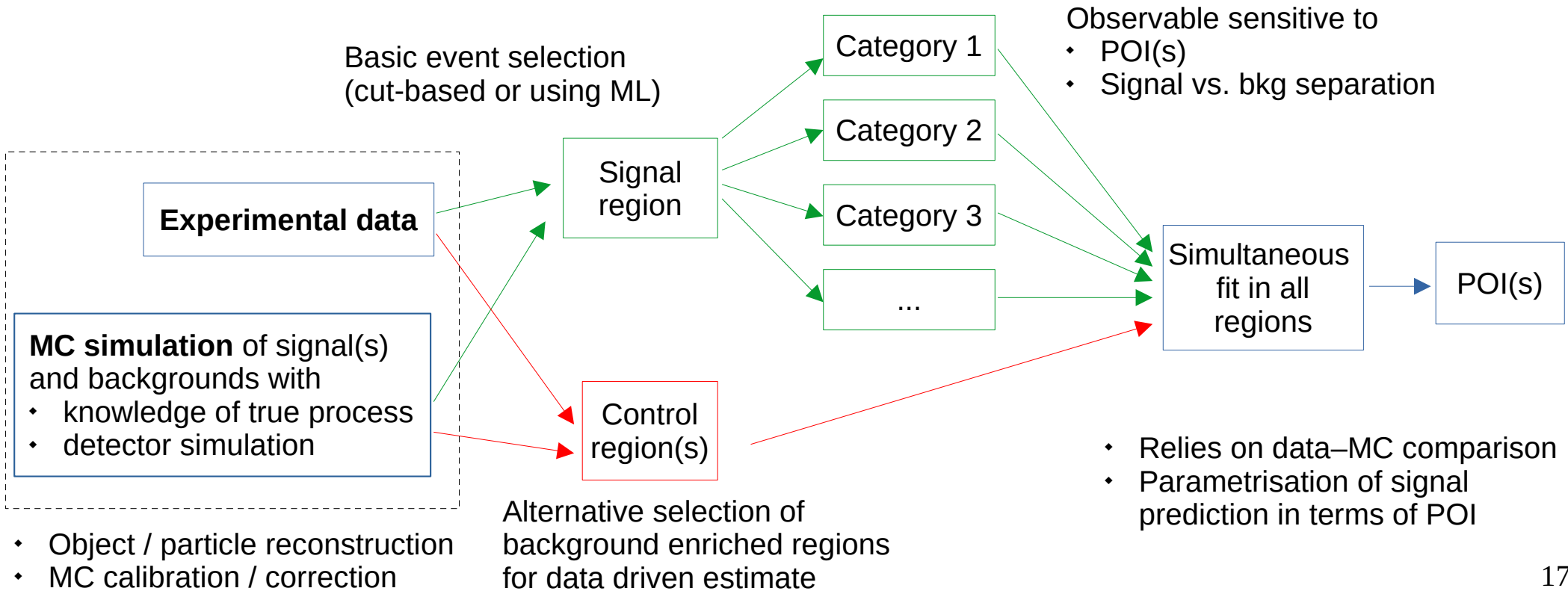
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# Typical analysis workflow

Event categorisation to:

- Split experimental signatures
- Def. regions with good signal significance or resolution
- Target different POIs

Observable sensitive to

- POI(s)
- Signal vs. bkg separation

Basic event selection  
(cut-based or using ML)

Experimental data

Signal region

Category 1

Category 2

Category 3

...

Simultaneous  
fit in all  
regions

POI(s)

**MC simulation of signal(s)  
and backgrounds with**

- knowledge of true process
- detector simulation

Control region(s)

**+ 1 constrained nuisance  
parameter / systematic**

- Relies on data–MC comparison
- Parametrisation of signal prediction in terms of POI

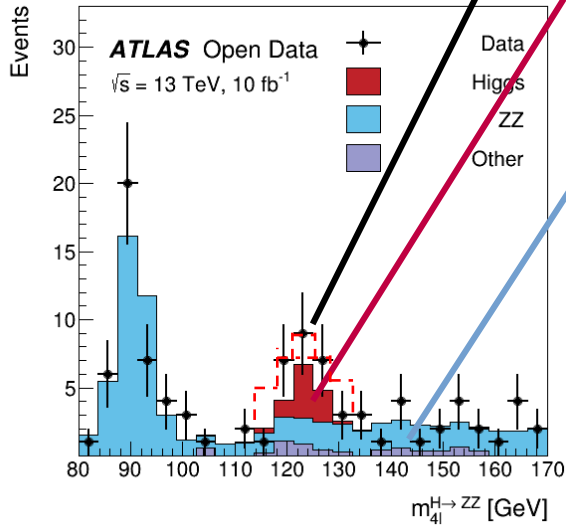
Alternative selection of  
background enriched regions  
for data driven estimate

- Object / particle reconstruction
- MC calibration / correction

# Interlude -- profile likelihood fit

$$\mathcal{L}(n|\mu, \theta) = \prod_{i \in \text{bins}} \mathcal{P}(n_i | \underbrace{\mu \cdot S_i(\theta) + B_i(\theta)}_{S+B \text{ prediction in bin } i})$$

observed bin contents  $\rightarrow$   $n_i$   
 parameters  $\rightarrow$   $\mu, \theta$



Here: POI = signal strength  $\mu$

Observable sensitive to

- POI(s)
- Signal vs. bkg separation

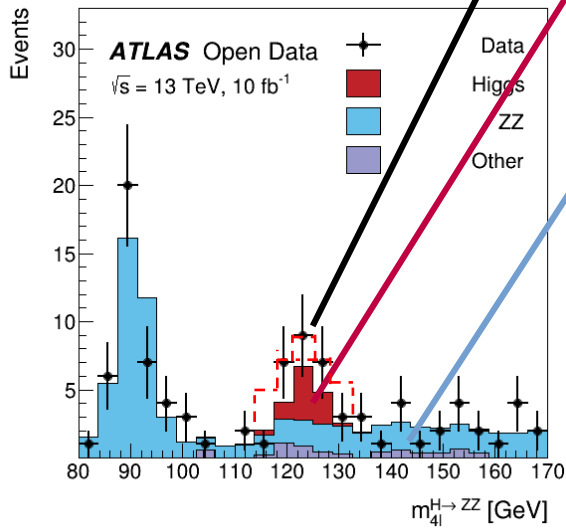
Simultaneous fit in all regions  $\rightarrow$  POI(s)

- Relies on data–MC comparison
- Parametrisation of signal prediction in terms of POI

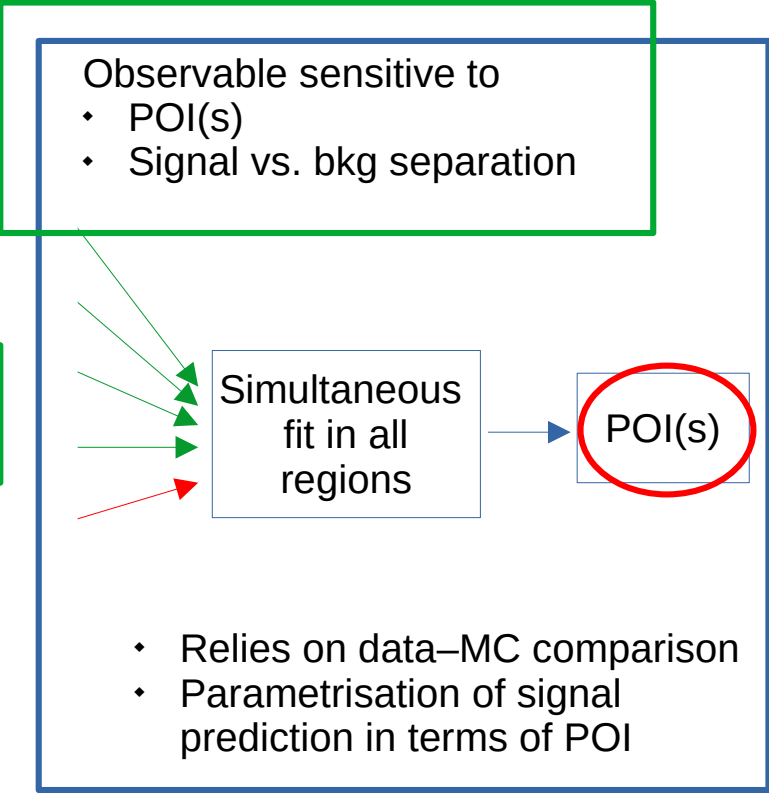
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observed bin contents  $\rightarrow$   $n_i$   
 parameters  $\rightarrow$   $\mu, \theta$



Here: 4-lepton invariant mass used to identify signal vs. background



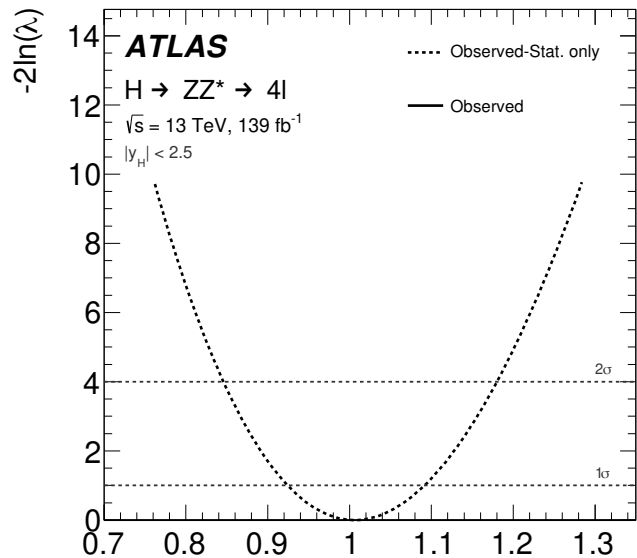
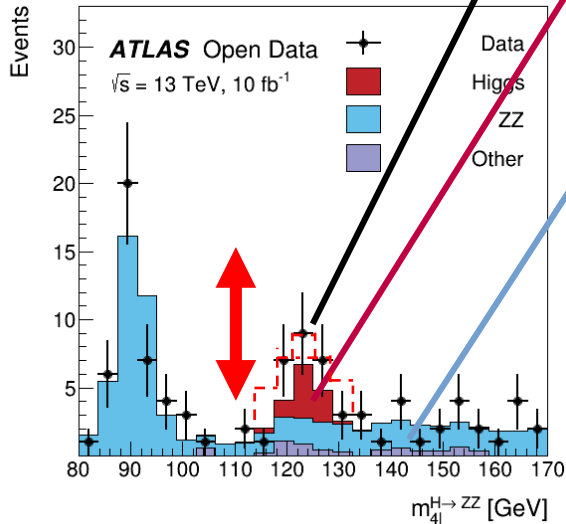
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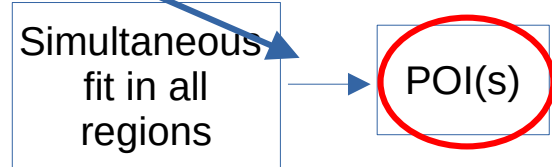
observed bin contents  $\rightarrow$   $n_i$   
 parameters  $\rightarrow$   $\mu, \theta$   
 Poisson  $\rightarrow$   $\mathcal{P}$   
 $\mu$  is circled in red.

Minimisation of  $-2\ln\mathcal{L}$



Observable sensitive to

- POI(s)
- Signal vs. bkg separation



- Relies on data-MC comparison
- Parametrisation of signal prediction in terms of POI

Here: POI = signal strength  $\mu$

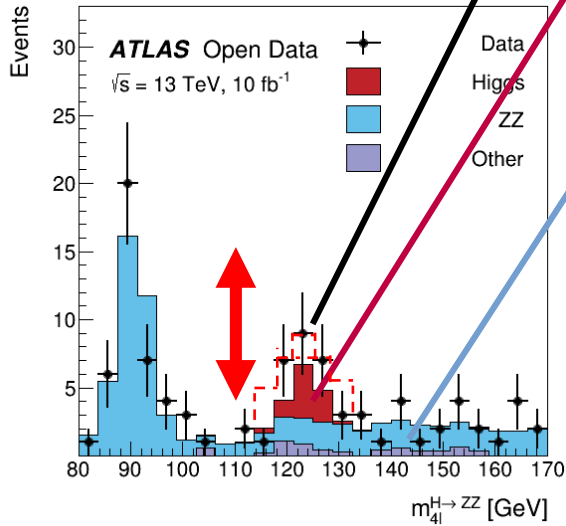


$\mu$

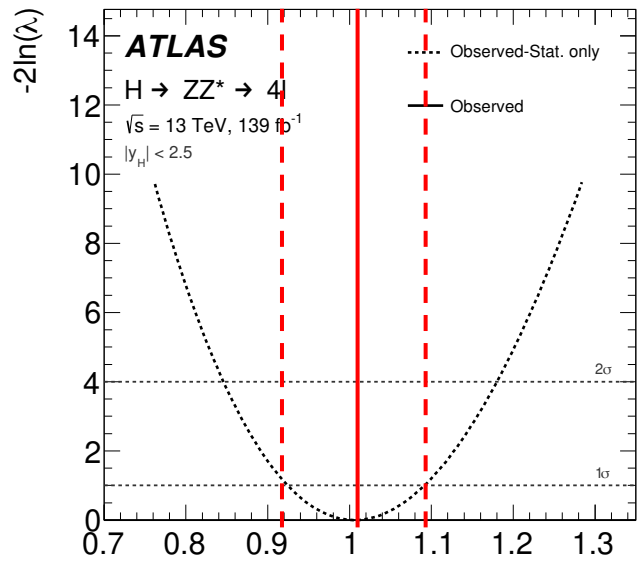
# Interlude -- profile likelihood fit

$$\mathcal{L}(n|\mu, \theta) = \prod_{i \in \text{bins}} \mathcal{P}(n_i | \underbrace{\mu}_{\text{parameters}} \cdot \underbrace{S_i(\theta) + B_i(\theta)}_{\text{S+B prediction in bin } i})$$

observed bin contents



Minimisation of  $-2\ln\mathcal{L}$



Best fit value +/- statistical uncertainty

Observable sensitive to

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Simultaneous fit in all regions

POI(s)

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# Interlude -- profile likelihood fit

1 parameter  
(POI)



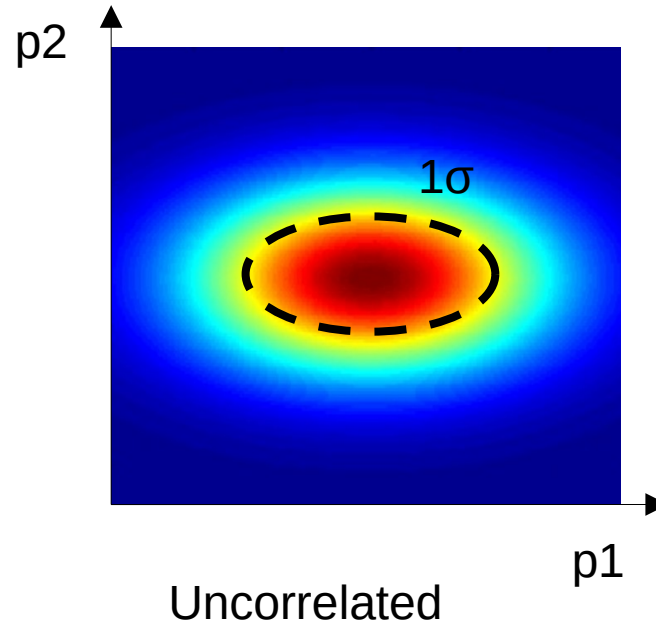
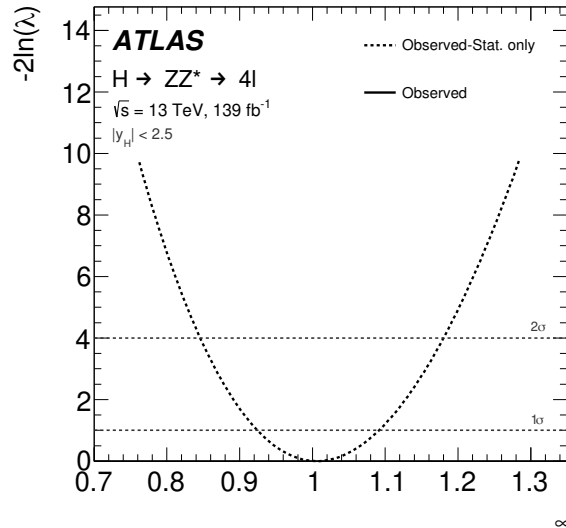
2 parameters (POIs or  
nuisance parameters)



...



N parameters



# Interlude -- profile likelihood fit

1 parameter  
(POI)



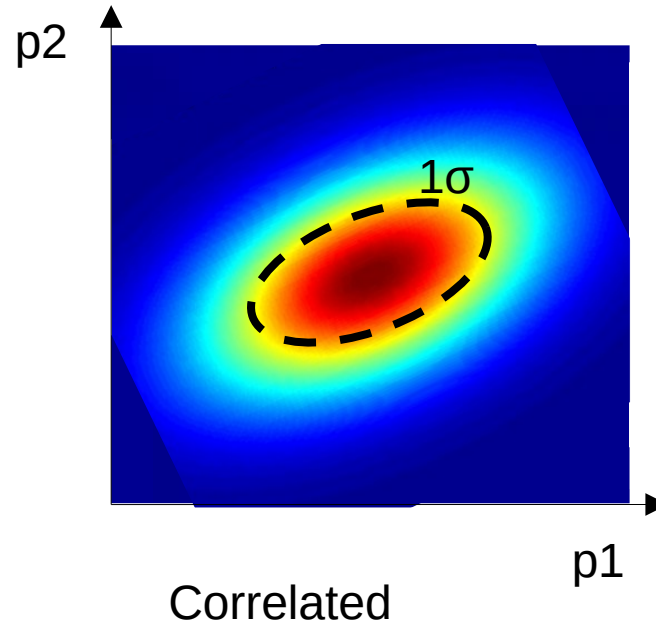
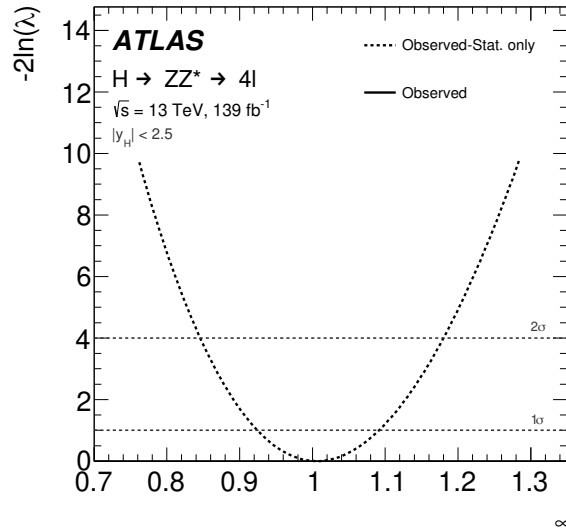
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# Interlude -- profile likelihood fit

1 parameter  
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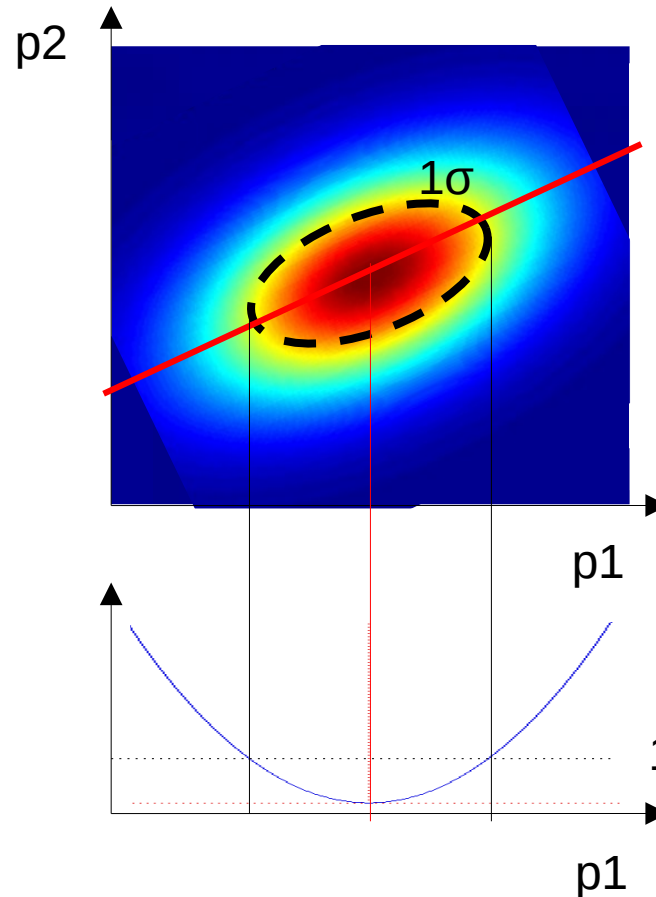
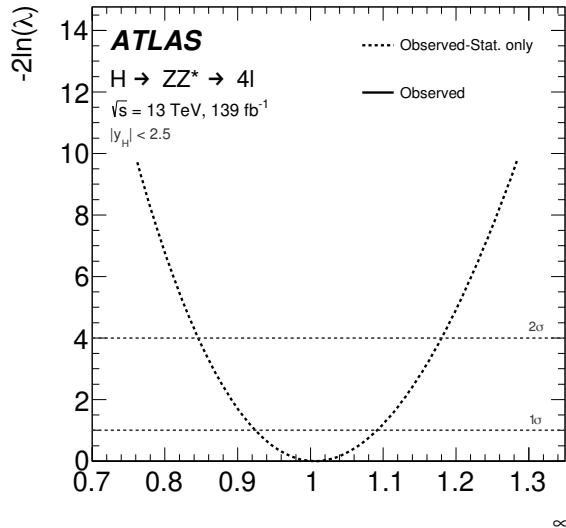
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N parameters



Profile likelihood scan of  $p1$ :  
In each value of  $p1$ ,  
minimise likelihood w.r.t.  $p2$

# Interlude -- profile likelihood fit

1 parameter  
(POI)



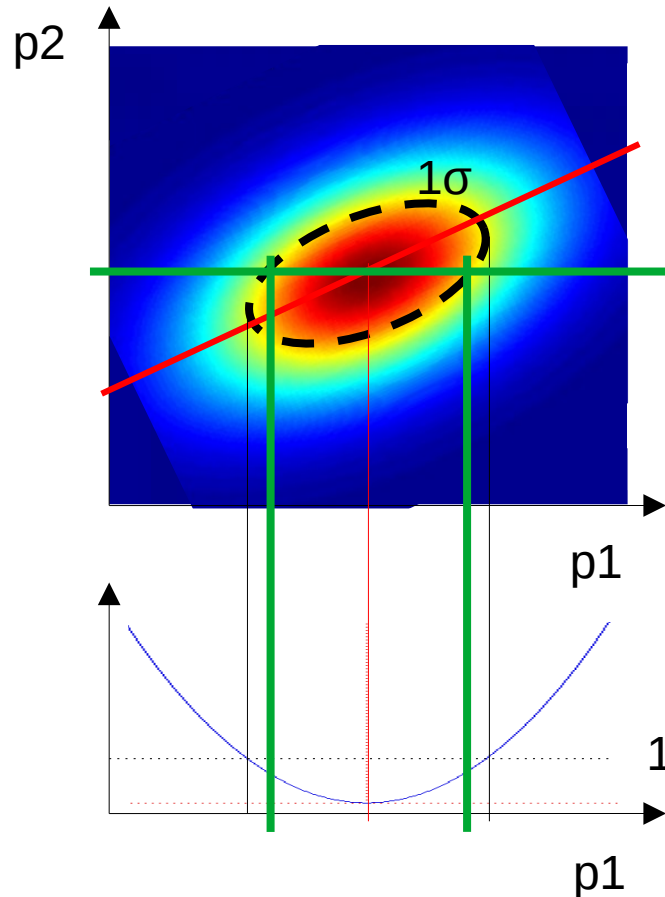
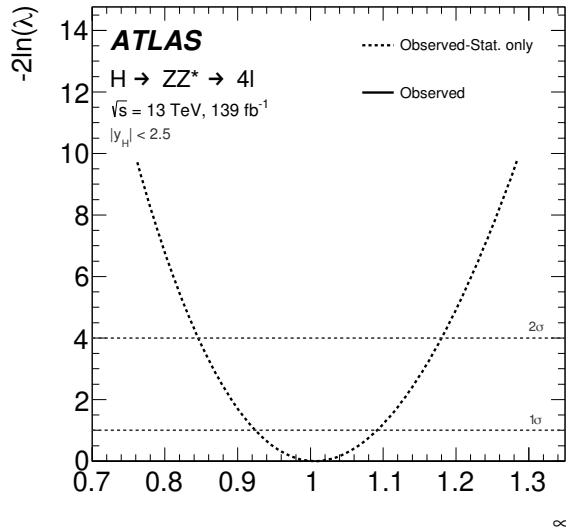
2 parameters (POIs or  
nuisance parameters)



...



N parameters



Compare: Simple scan of  $p1$   
for fixed value of  $p2$

Profile likelihood scan of  $p1$ :  
In each value of  $p1$ ,  
minimise likelihood w.r.t.  $p2$



# Interlude -- profile likelihood fit

1 parameter  
(POI)



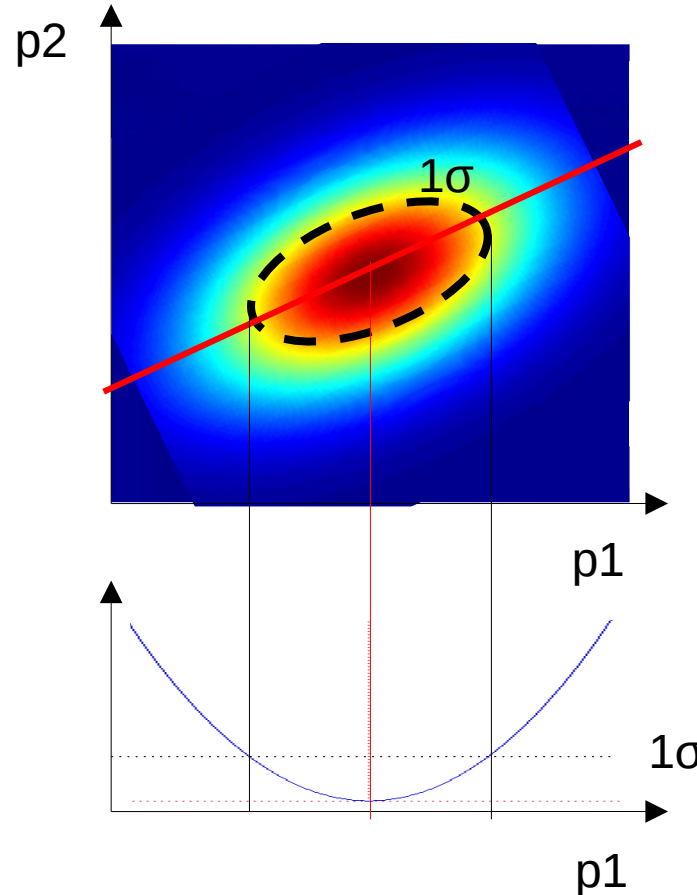
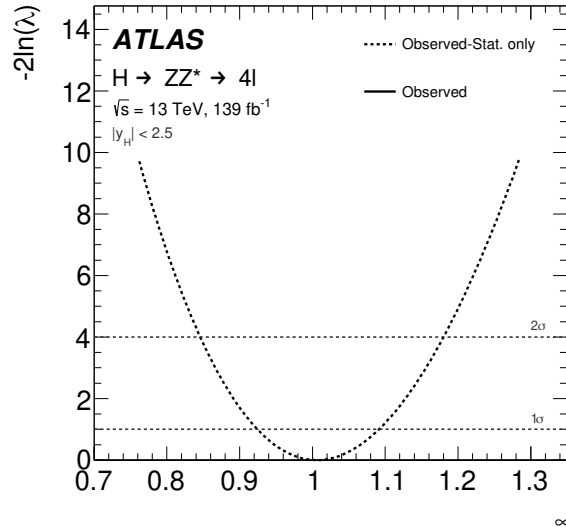
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...



N parameters



## Note:

- P2 can be another POI or a nuisance parameter, e.g. systematic uncertainty
- 2D contour is nice ellipse in case of all-Gaussian behaviour – can have other shape in case of more complicated dependences (quadratic terms etc.)

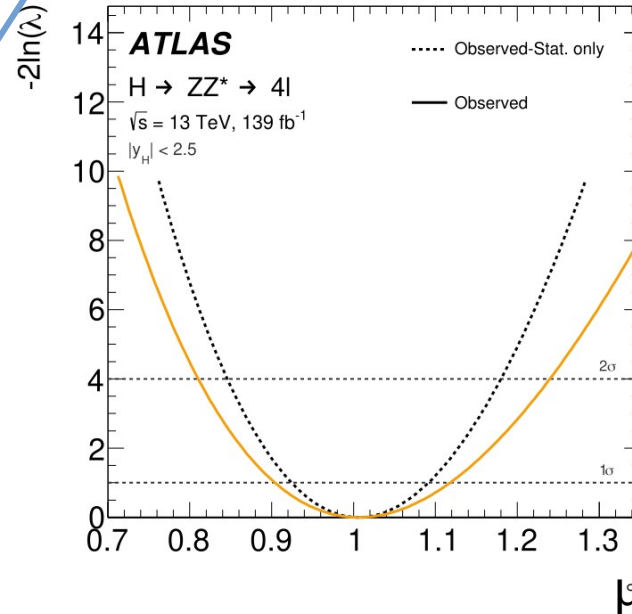
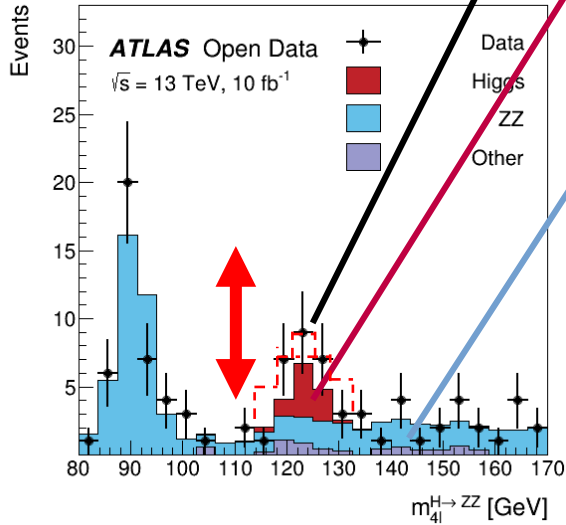
# Interlude -- profile likelihood fit

Additional freedom in likelihood allowing prediction to vary within uncertainties with Gaussian distribution

$$\mathcal{L}(n|\mu, \theta) = \prod_{i \in bins} \mathcal{P}(n_i | \mu \cdot S_i(\theta) + B_i(\theta)) \times \prod_{i \in sust} \mathcal{G}(\theta_j^0 | \theta_j, \Delta\theta_j)$$

observed bin contents →  $n_i$   
 parameters →  $\mu, \theta$   
 Poisson →  $\mathcal{P}(n_i | \dots)$   
 S+B prediction in bin  $i$  →  $\mu \cdot S_i(\theta) + B_i(\theta)$   
 Gaussian distribution →  $\mathcal{G}(\theta_j^0 | \theta_j, \Delta\theta_j)$

Minimisation of  $-2\ln\mathcal{L}$



Observable sensitive to

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Simultaneous fit in all regions

POI(s)

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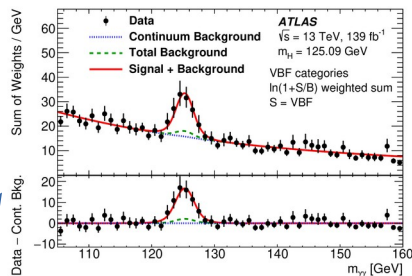
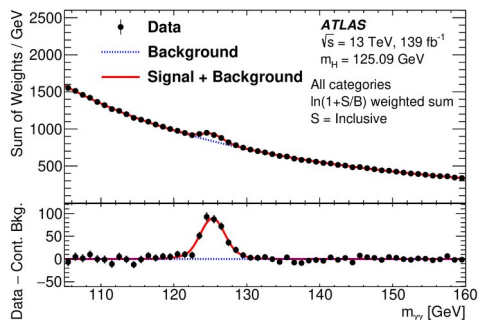
Here: POI = signal strength  $\mu$

# Example: Higgs to diphoton

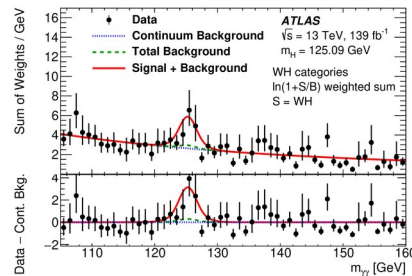
Event categorised to target Higgs production mode

Result: cross section of Higgs decaying to 2 photons in different production modes + associated correlation matrix

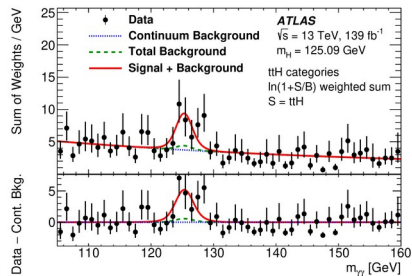
Basic reconstruction & selection of photon pair



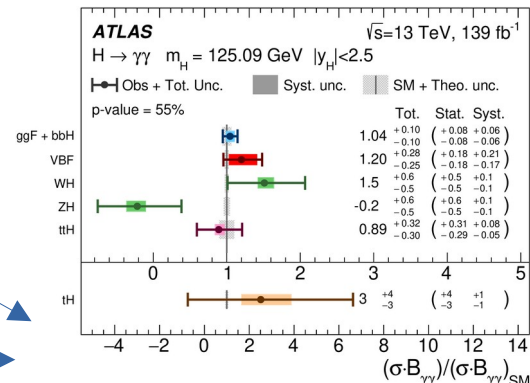
VBF ~ Higgs + 2 forward jets



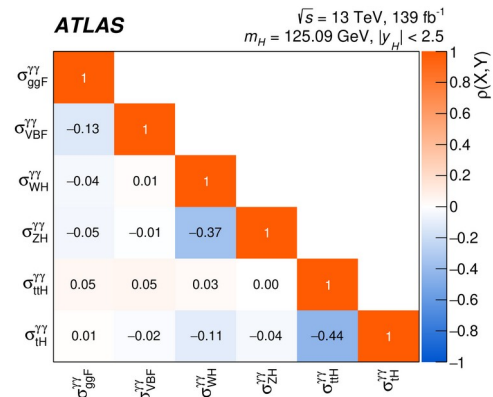
WH ~ Higgs + 2 leptons



ttH ~ Higgs + 2 tops



Simultaneous fit to diphoton mass



# Content

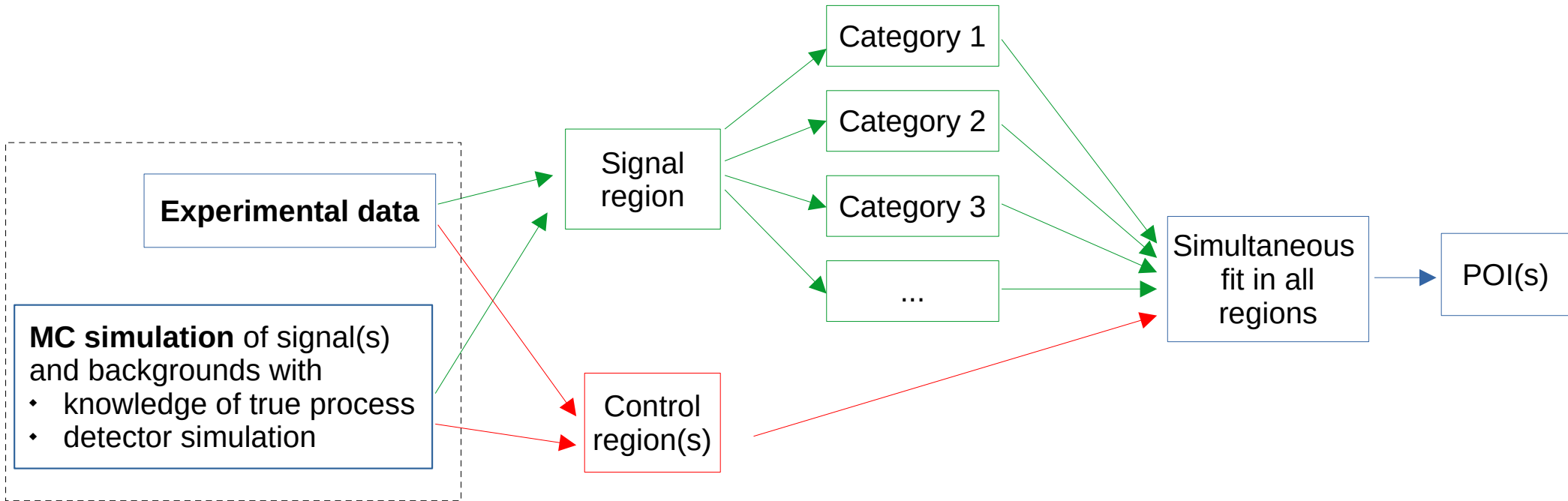
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# EFT model and basis

- Several different EFT models with different underlying assumptions: SMEFT, HEFT, ...
  - ◆ Choice depending on physics models to be probed (Higgs physics, B physics, etc.)
- Described by complete and orthogonal basis of operators; several bases possible
  - ◆ In principle, can easily convert one to the other
  - ◆ Basis choice depends on measured processes – basis can be defined such that operators correspond to modifications of physical couplings, or, in contrary, should be general and useful for all measurements
- Operator set might be reduced by requiring additional symmetries, if measurement is not sensitive e.g. to flavour etc.
- More details in theory introduction and dedicated lectures on Higgs+EW and flavour physics
  - ◆ Overview of (equivalent) bases in [this LHCXSWG note](#)

# Where do EFT enter in the analysis?





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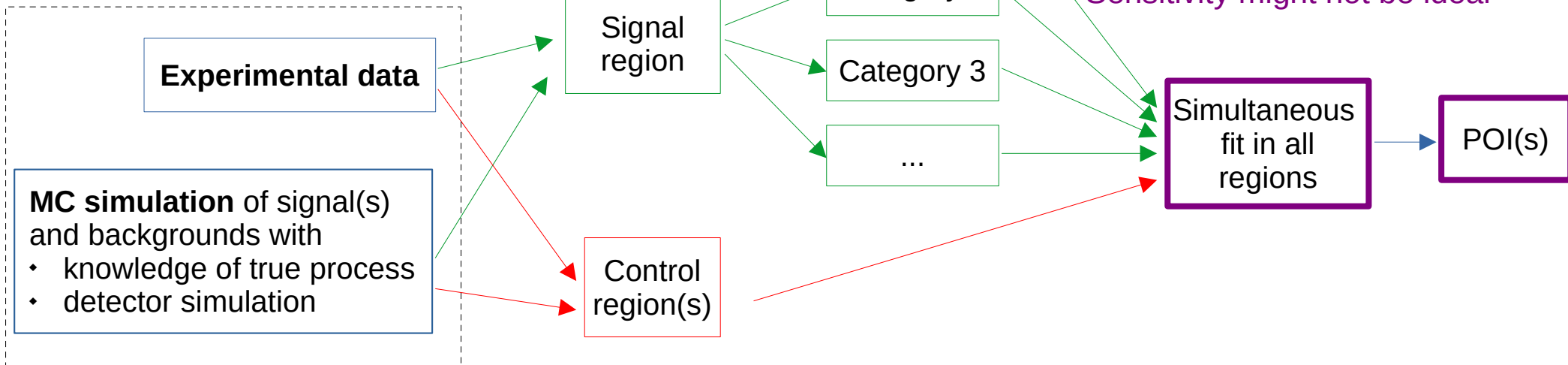
## Option 1: Parametrisation of results

Pros:

- Fast and exact EFT impact computed at truth level
- Straight forward to handle interference between operators

Cons:

- Analysis acceptance calculated only from SM samples
- Sensitivity might not be ideal



# Where do EFT enter in the analysis?

## Option 2: Use alternative signal model with EFT contributions

Pros:

- Propagation through full analysis procedure
- Possibility to optimise analysis for EFT sensitivity
- Suited for single EFT operator fit

Cons:

- Heavy due to full detector simulation
- Interpolation between values of Wilson coefficients
- Becomes very complex for global EFT fit

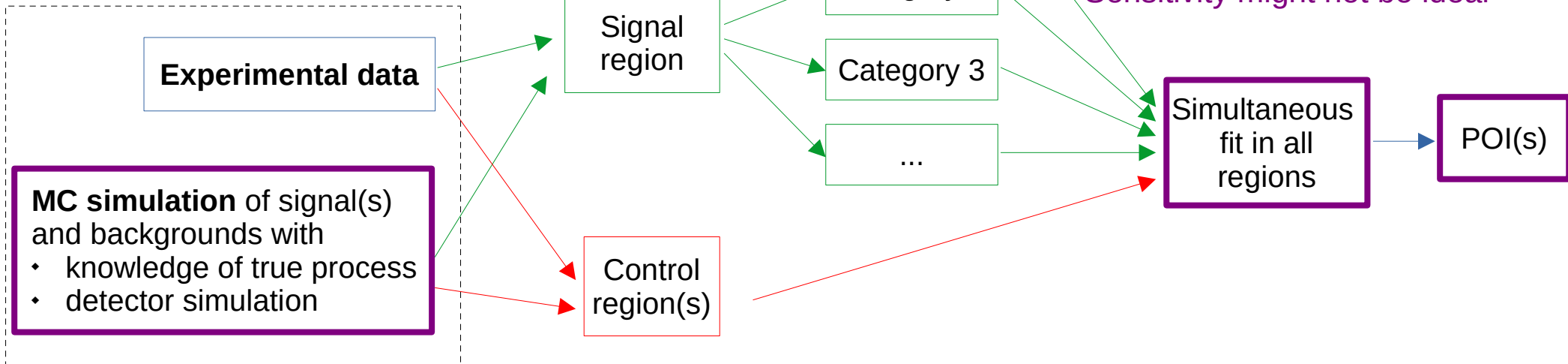
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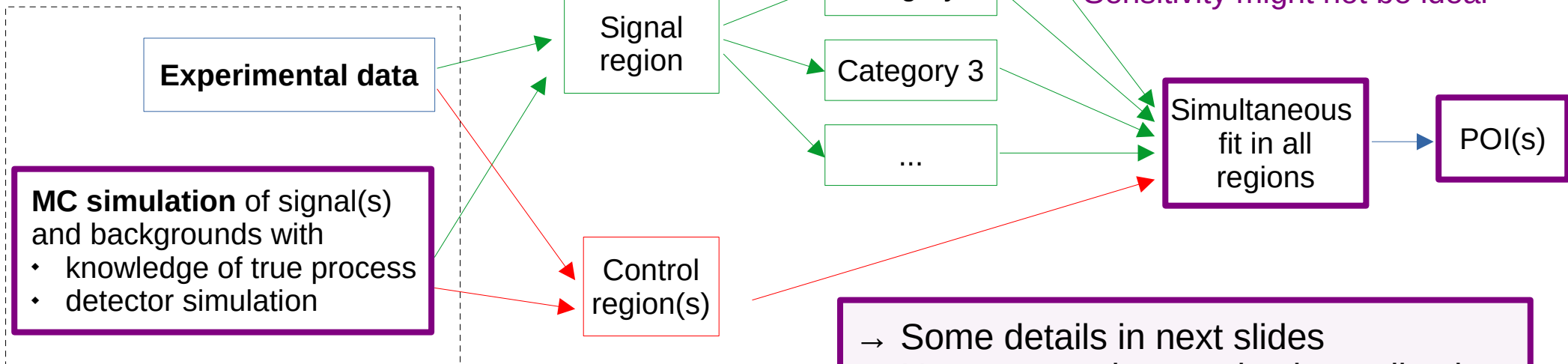
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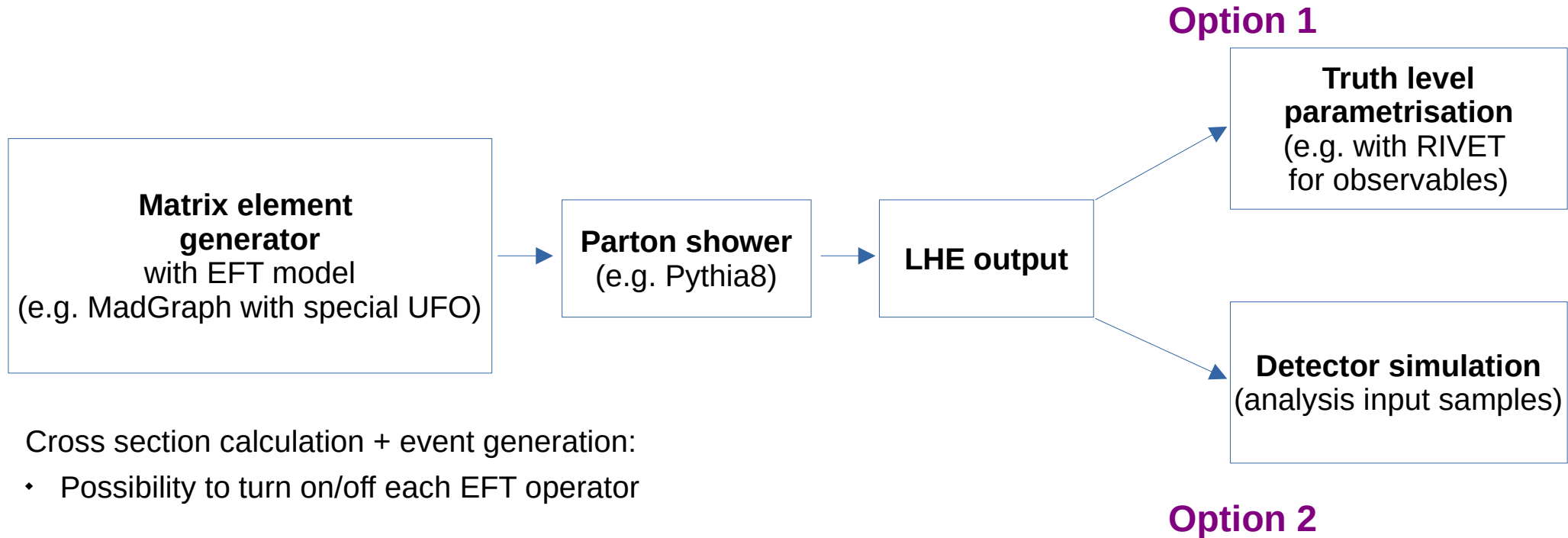
→ Some details in next slides  
→ Use case and examples in applications for Higgs+EW & flavour

# Building the EFT parametrisation

- Numerous tools on the market to simulate EFT impact on specific processes
- Implemented e.g. as MadGraph UFOs -- allowing to generate MC with EFT contribution

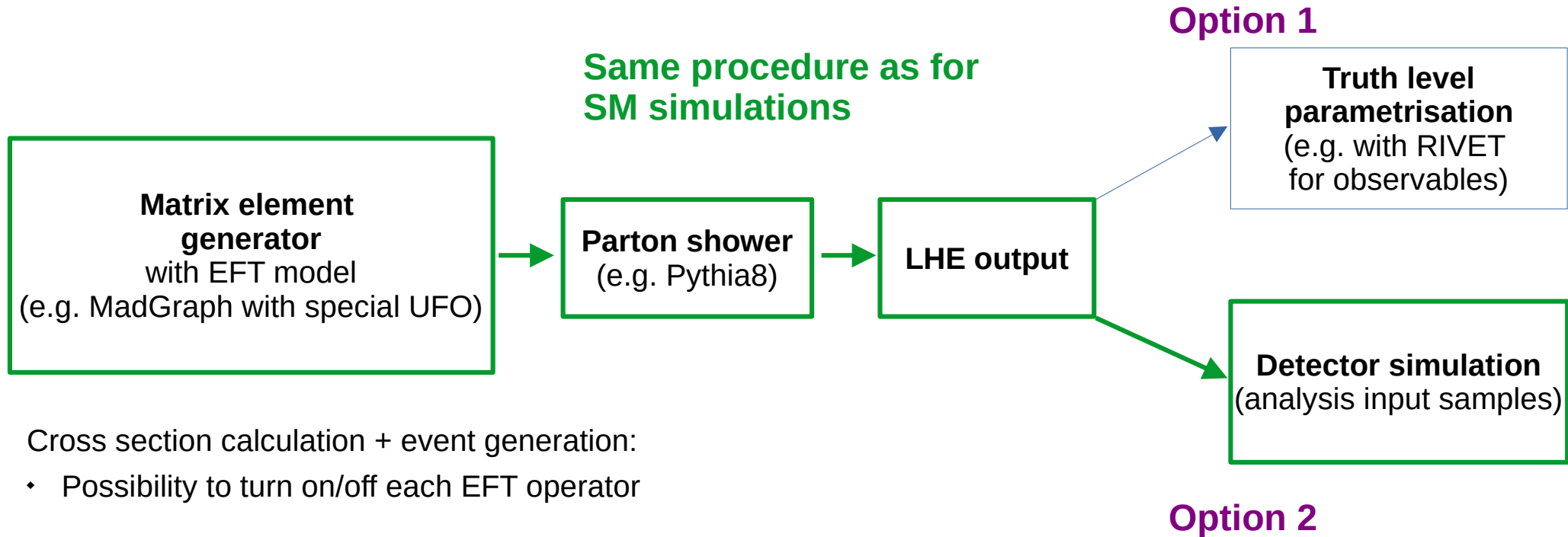
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# Step-by-step: event generation



# Dimension and order – example SMEFT

The general SMEFT Lagrangian contains the SM (dim-4 operators) + higher (even) order operators (odd dimension operators are lepton number violating)

$$\mathcal{L}_{\text{SMEFT}} = \mathcal{L}_{\text{SM}}^{(4)} + \frac{1}{\Lambda^2} \sum_i^{N_6} c_i \mathcal{O}_i^{(6)} + \frac{1}{\Lambda^4} \sum_j^{N_8} c_j \mathcal{O}_j^{(8)} + \dots$$

Leading BSM → often only  
consider dim-6 operators



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Leading BSM → often only consider dim-6 operators

The cross section of a process corresponds to the squared amplitude; it will contain interference terms between the SM and BSM operators, as well as pure BSM contributions.

$$\sigma_{\text{SMEFT}} \sim |A_{\text{SMEFT}}|^2 = \left[ \text{SM} \right]^2 + 2 \frac{c}{\Lambda^2} \text{Re} \left( \text{SM} \times \text{BSM} \right) + \frac{c^2}{\Lambda^4} \left[ \text{BSM} \right]^2$$

**SM**
**Linear : SM x d=6 interference**
**Quadratic : (d=6)<sup>2</sup>**

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$||^2$

The cross section of a process corresponds to the squared amplitude; it will contain interference terms between the SM and BSM operators, as well as pure BSM contributions.

$$|\mathcal{M}_{\text{SMEFT}}|^2 \sim \sigma = \sigma_{\text{SM}} + \sigma_{\text{int}} + \sigma_{\text{BSM}}$$

$\sim 1/\Lambda^2$  for dim-6 EFT       $\sim 1/\Lambda^4$  for dim-6 EFT

$\sim |\mathcal{M}_{\text{SM}} \cdot \mathcal{M}^{(6)}|^2$        $\sim |\mathcal{M}^{(6)}|^2$

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- › In general, the interference term is leading, but quadratic (“BSM”) terms can have a significant impact.
- › Interference terms with dim-8 operators have same order in  $1/\Lambda^2$  than dim-6 quadratic terms

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Leading BSM  $\rightarrow$  often only consider dim-6 operators

Theory calculations ongoing, but heavy dominant BSM contribution to certain processes

The cross section of a process corresponds to the squared amplitude; it will contain interference terms between the SM and BSM operators, as well as pure BSM contributions.

$$\sigma = \sigma_{\text{SM}} + \underbrace{\sigma_{\text{int}}}_{\sim 1/\Lambda^2 \text{ for dim-6 EFT}} + \underbrace{\sigma_{\text{BSM}}}_{\sim 1/\Lambda^4 \text{ for dim-6 EFT}}$$

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- › Interference terms with dim-8 operators have same order in  $1/\Lambda^2$  than dim-6 quadratic terms

# Input parameters & symmetries

## Input parameters

- The SM depends on a set of free parameters that need to be measured (masses, widths, QCD constants, mixing angles, etc.) – need to define minimal complete set of free parameters
- Additional free parameters in EFT: energy scale  $\Lambda$  and Wilson Coefficients  $c_i$  – in practice, hard to make simultaneous measurement of Wilson Coefficients and SM parameters → need input values
- Choice of input parameter set & measurements can depend on use case and should fulfill some criteria (e.g. on precision, decorrelation from EFT contributions, etc.)
- Note: for a global EFT combination, input parameter choice needs to be consistent

## Symmetries

- Full EFT formulation yields large number of independent operators – not all of them can be constrained by every analysis
- Number of operators can be reduced a priori in some cases by requiring certain symmetries, e.g.  $U(3)^5$  flavour symmetry – e.g. VH production in  $H \rightarrow b\bar{b}$  decay has no sensitivity to discriminate between fermion generations

# EFT calculation order

- For some processes, SM calculations available at high order (NNLO, N3LO,...)
- EFT models often “only” available at LO or NLO

**Solution:** assume k-factor between LO and higher order is similar for SM and EFT

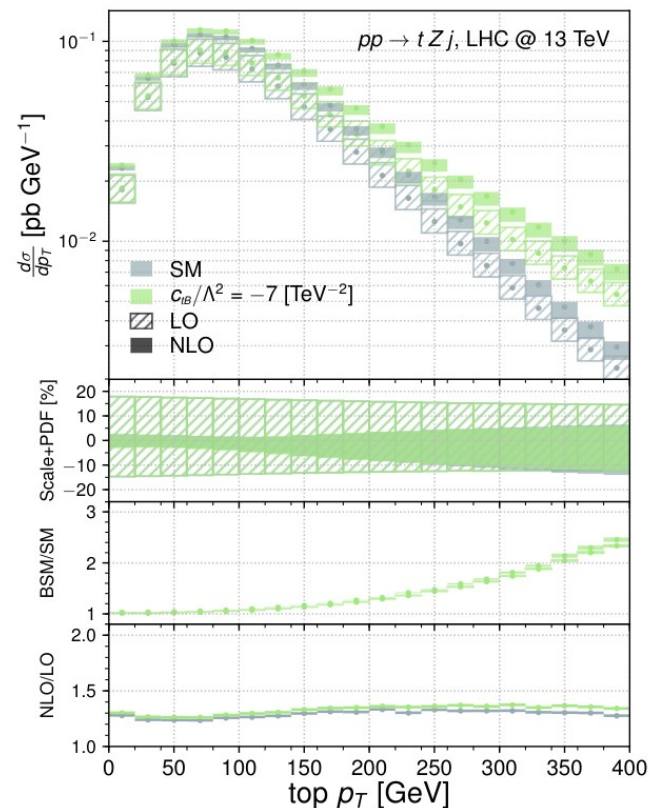
→ compute relative EFT correction to SM prediction

$$\sigma = \sigma_{\text{SM}}^{(\text{N})\text{NLO}} \cdot \left( 1 + \frac{\sigma_{\text{int}}^{\text{LO}}}{\sigma_{\text{SM}}^{\text{LO}}} + \frac{\sigma_{\text{BSM}}^{\text{LO}}}{\sigma_{\text{SM}}^{\text{LO}}} \right)$$

Note:

- not ideal for every process
- should know EFT at least at leading order of specific process

Example: transverse top momentum in  $pp \rightarrow tZj$  production



# Step-by-step: parametrisation

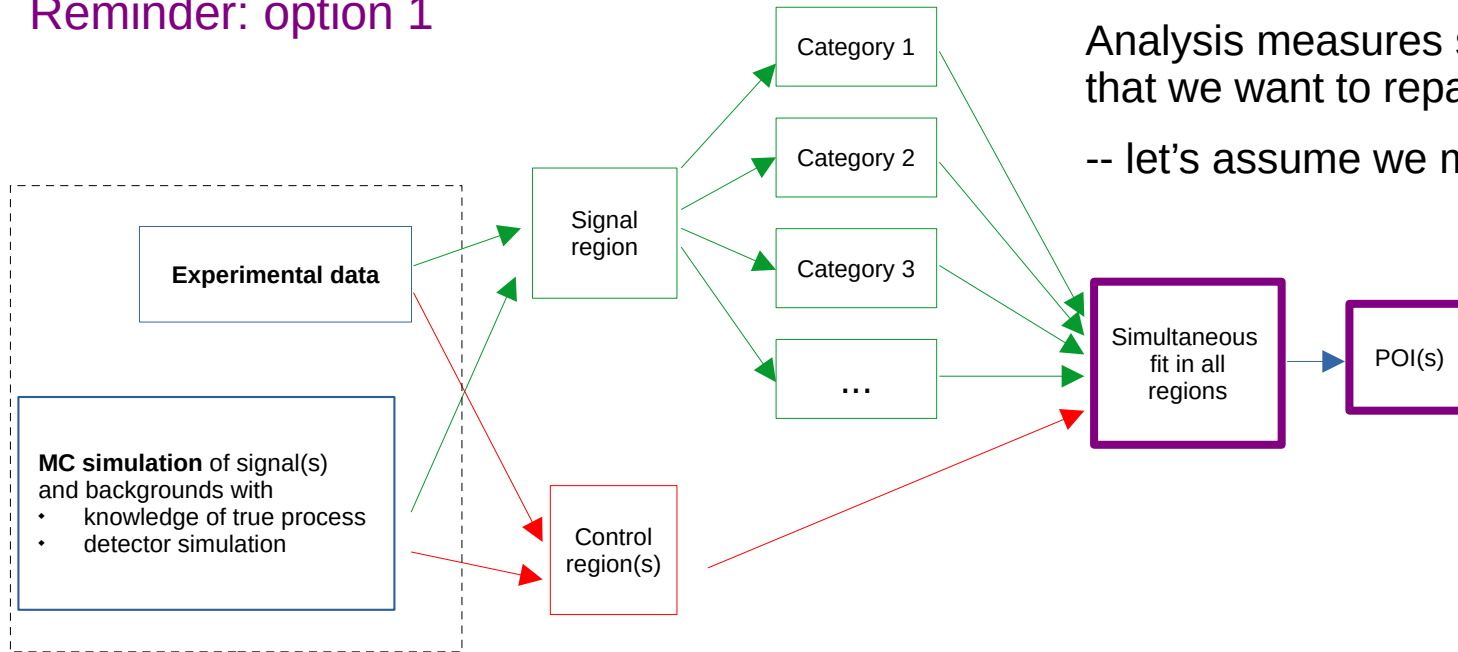


# Building the EFT parametrisation



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## Reminder: option 1

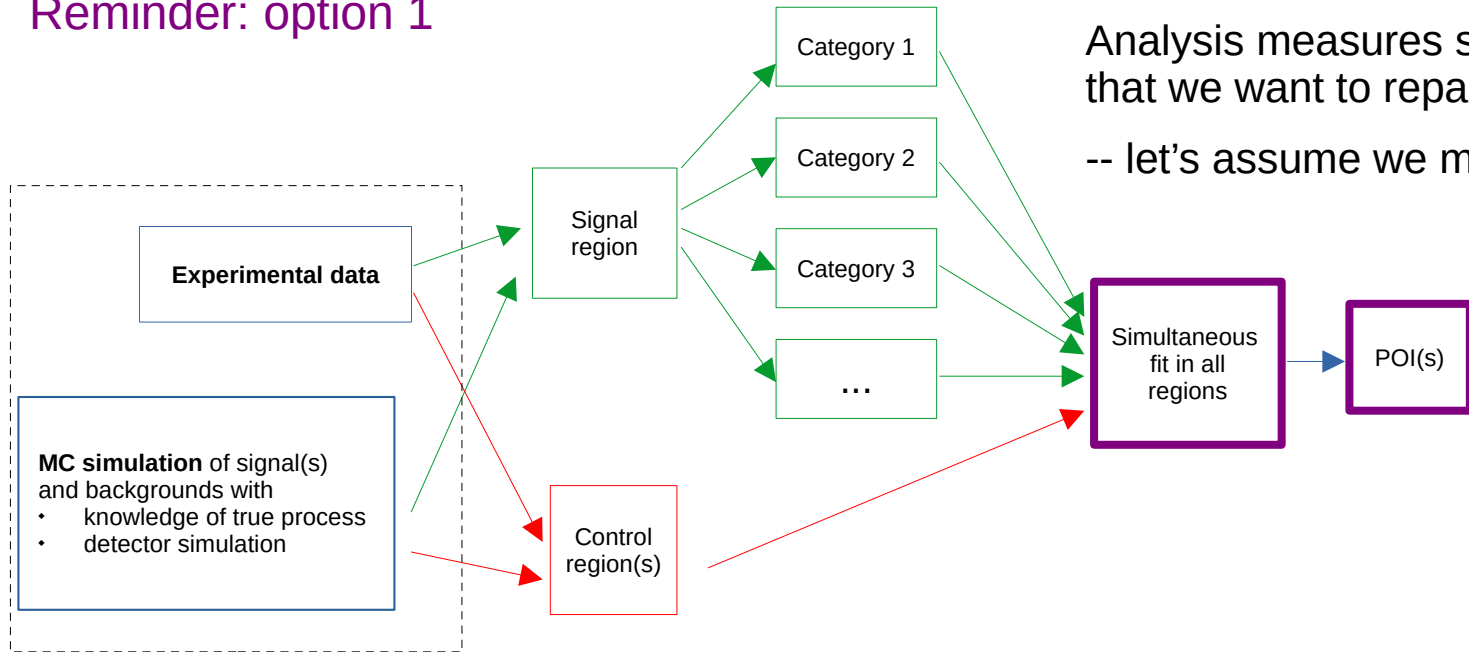


Analysis measures some observable / parameter that we want to reparametrise in terms of EFT

-- let's assume we measure a **cross section  $\sigma$**

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Analysis measures some observable / parameter that we want to reparametrise in terms of EFT

-- let's assume we measure a **cross section  $\sigma$**

$$\sigma = \sigma_{\text{SM}} + \sigma_{\text{int}} + \sigma_{\text{BSM}}$$

Value observed in data

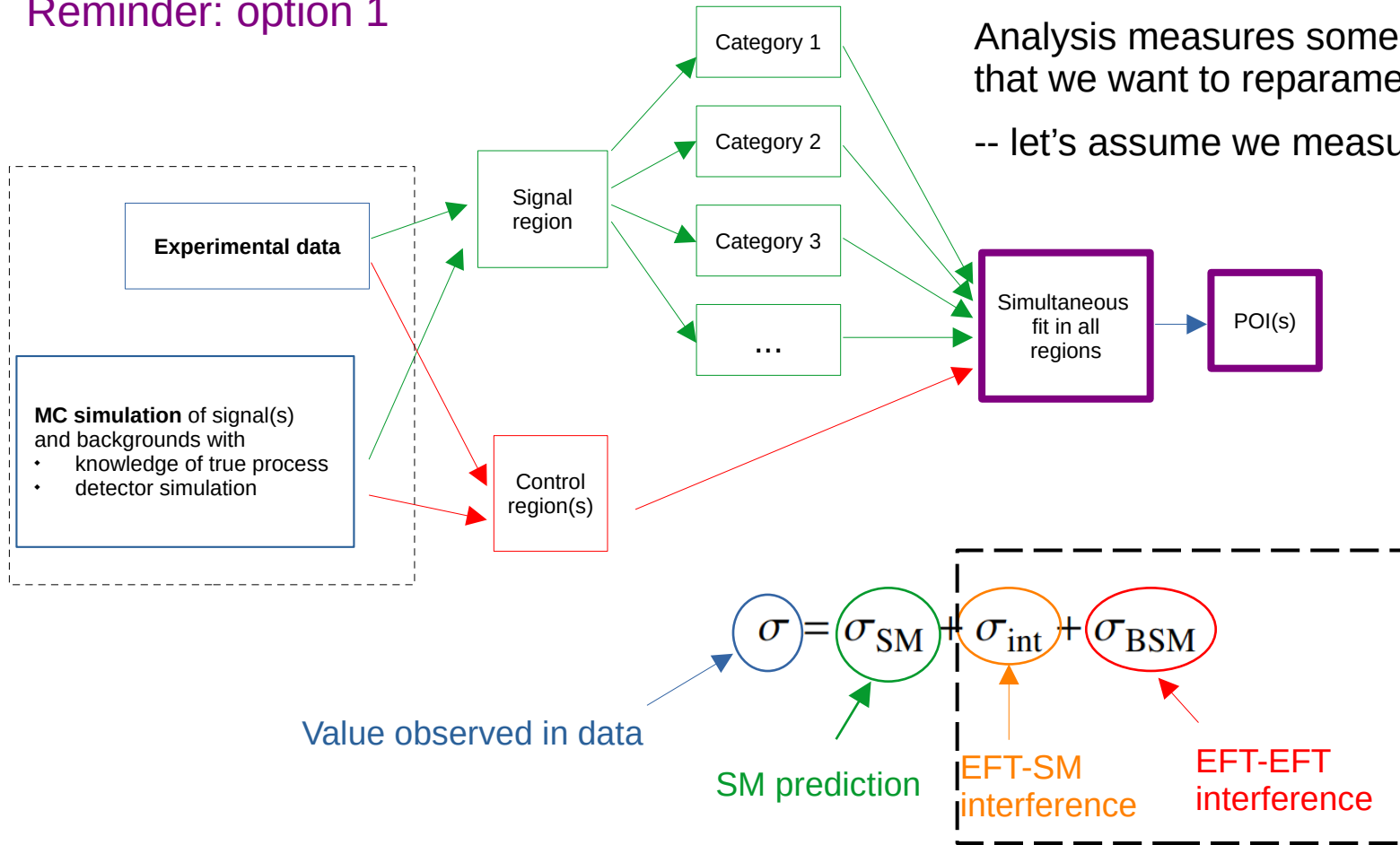
SM prediction

EFT-SM interference

EFT-EFT interference

# Building the EFT parametrisation

Reminder: option 1

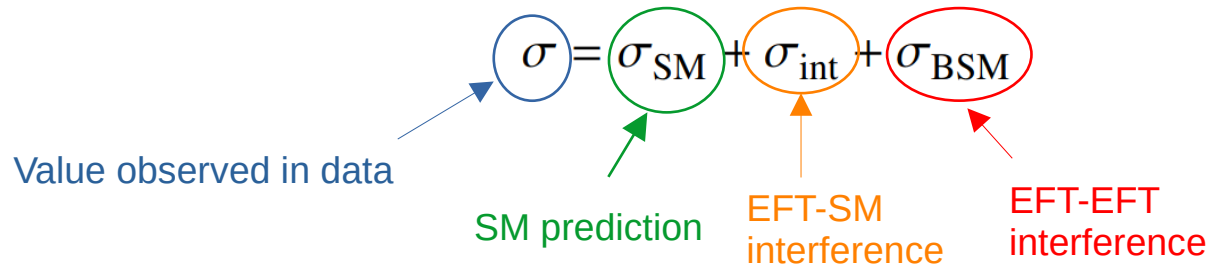


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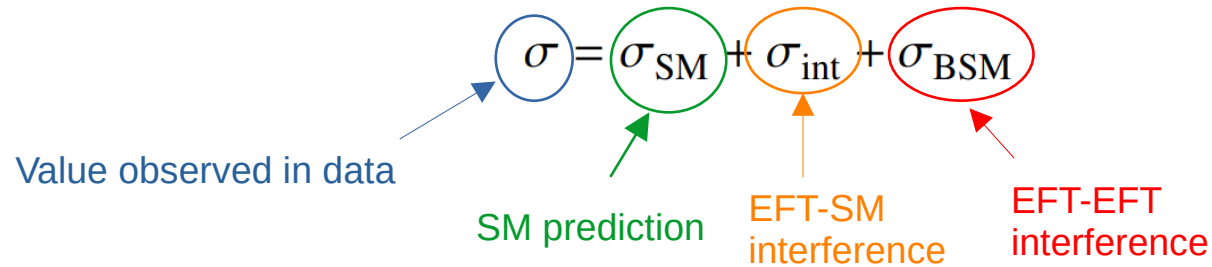
BSM contributions that we want to constrain

# Building the EFT parametrisation



$$\sigma = \sigma_{\text{SM}}^{(\text{N})\text{NLO}} \cdot \left( 1 + \frac{\sigma_{\text{int}}^{\text{LO}}}{\sigma_{\text{SM}}^{\text{LO}}} + \frac{\sigma_{\text{BSM}}^{\text{LO}}}{\sigma_{\text{SM}}^{\text{LO}}} \right) = \sigma_{\text{SM}}^{(\text{N})\text{NLO}} \cdot \left( 1 + \underbrace{\sum_i A_i c_i}_{\text{orange}} + \underbrace{\sum_{ij} B_{ij} c_i c_j}_{\text{red}} \right)$$

# Building the EFT parametrisation

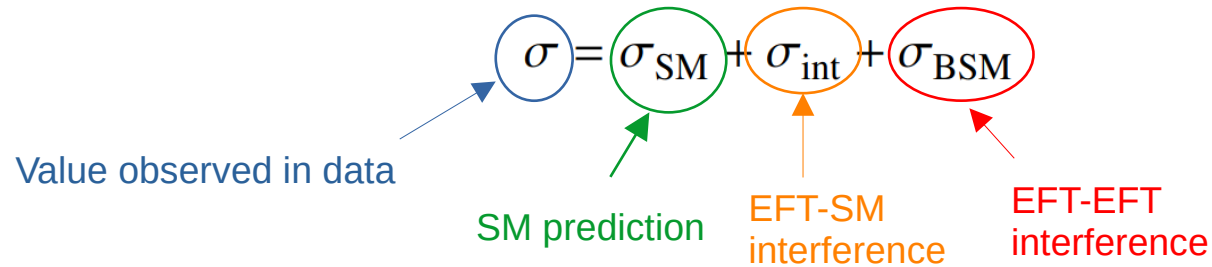


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Relative effect of BSM model (EFT operator) on  $\sigma$ : **constant factors computed from MC simulation**

Wilson coefficients (coupling strength associated to EFT operator): **POI of the fit**

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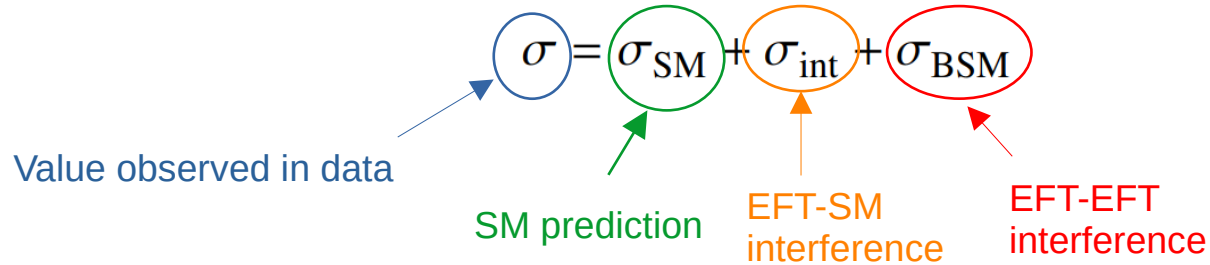
Wilson coefficients (coupling strength associated to EFT operator): **POI of the fit**

Some generators allow to simulate EFT-SM interference and pure EFT terms separately

Simple linear or quadratic dependence on Wilson coefficients

→ simulation for a few values of  $c_i$  sufficient to compute constant coefficients  $A_i$  and  $B_{ij}$

# Building the EFT parametrisation



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## Example

Using MadGraph with separate simulation of  $\sigma_{\text{int}}$  and  $\sigma_{\text{BSM}}$ , need:

- SM: 1 sample
- $A_i$ : 1 sample / operator (e.g.  $c_i = 1$ )
- $B_{ij}$ : 1 sample / operator (e.g.  $c_i = 1$ )
- $B_{ij}$ : 1 sample / operator pair (e.g.  $c_i = c_j = 1$ )

Relative effect of BSM model (EFT operator) on  $\sigma$ : **constant factors computed from MC simulation**

Wilson coefficients (coupling strength associated to EFT operator): **POI of the fit**

Simple linear or quadratic dependence on Wilson coefficients

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# Option 1 -- application

- Example on previous slide is basic example with one input measurement -- in practice, usually use differential cross sections and/or input from several analyses
- Under fully Gaussian assumption, can work with public results: measurement results with corresponding covariance matrix

$$\chi^2 = (P - \mu) C^{-1} (P - \mu)^T$$

Measurement covariance matrix

Prediction vector:

Measurement vector

$$P^i = \sigma_r^i X \left( 1 + \sum_i A_i c_i + \sum_{ij} B_{ij} c_i c_j \right)$$



# Option 1 -- application

Example: Higgs to diphoton differential cross sections

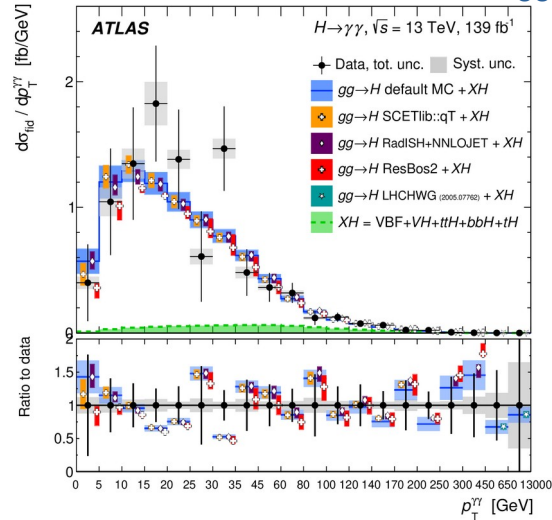
$$\chi^2 = (P-\mu) C^{-1} (P-\mu)^T$$

↑  
Measurement vector

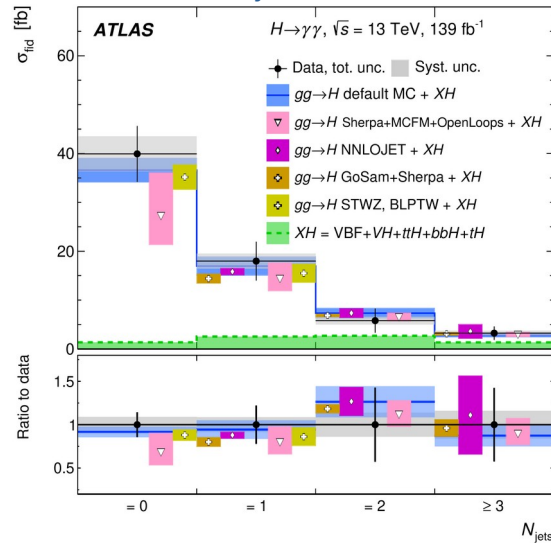
Input measurements:

Differential cross section as a function of several kinematic quantities of the diphoton system or associated particles

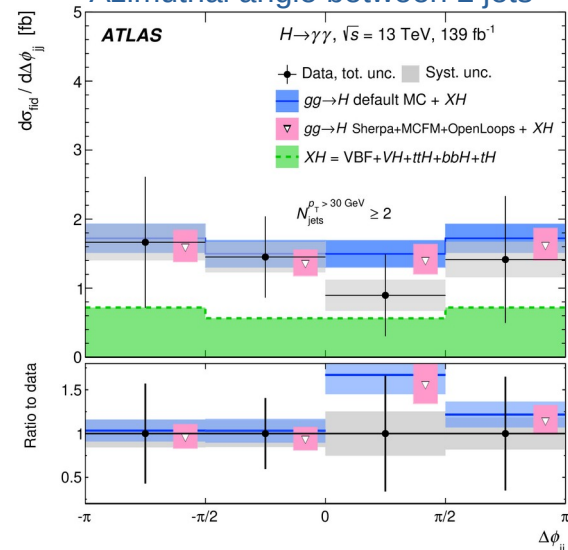
Transverse momentum of the reco Higgs



Number of jets in the event



Azimuthal angle between 2 jets



+ ...

# Option 1 -- application

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Measurement covariance matrix

Measurement vector

## Covariance matrix:

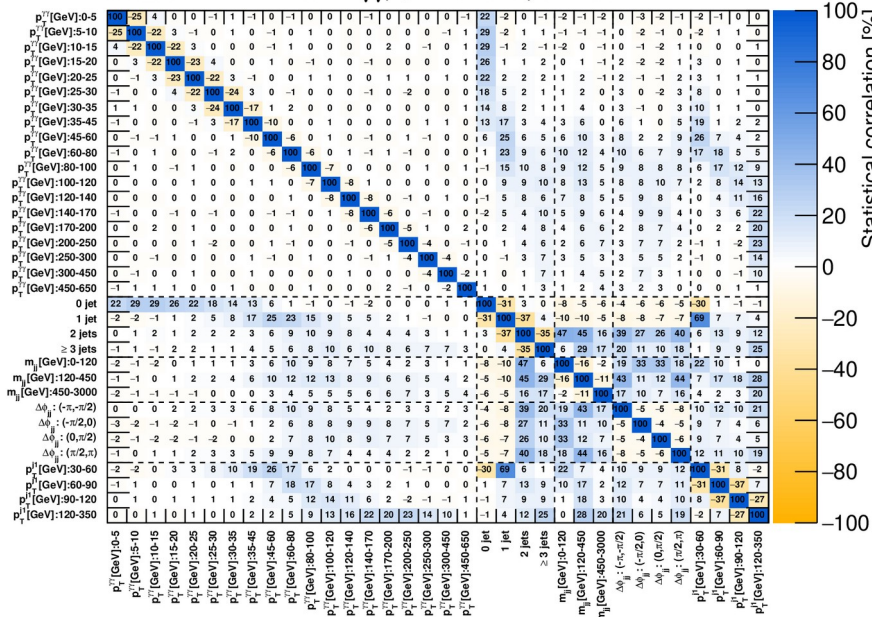
Correlations between measurements, i.e. between bins of each differential distribution and between distributions

Transverse momentum of the reco Higgs

Number of jets in the event

Azimuthal angle between 2 jets

ATLAS  $H \rightarrow \gamma\gamma, \sqrt{s} = 13\text{TeV}, 139 \text{ fb}^{-1}$



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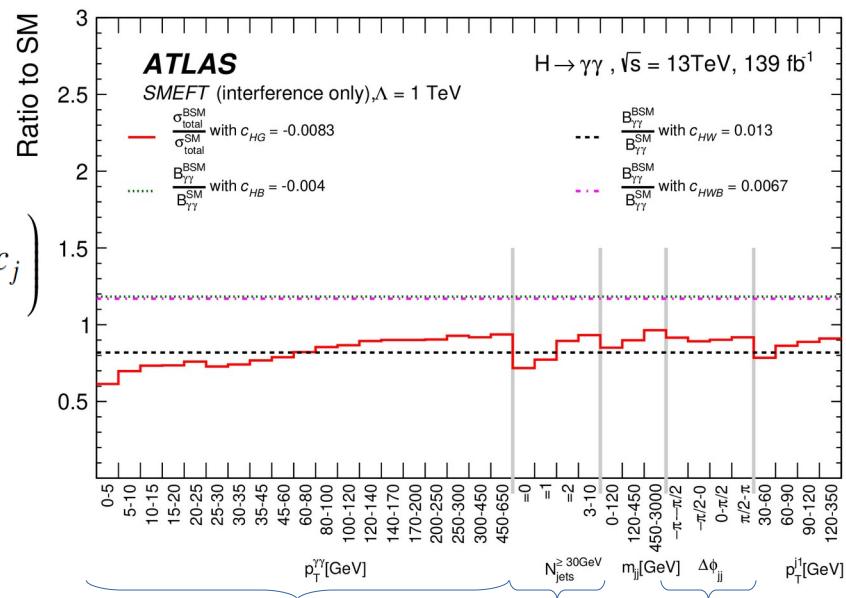
Prediction vector →  $(P-\mu)$ 
Measurement covariance matrix ←  $C^{-1}$ 
Measurement vector ←  $(P-\mu)^T$

Prediction:

Parametrisation in terms of EFT operators from truth level MC simulation for chosen operators

$$P^i = \sigma_r^i \chi \left( 1 + \sum_i A_i c_i + \sum_{ij} B_{ij} c_i c_j \right)$$

Similar parametrisation for corresponding CP-odd operators



Transverse momentum of the reco Higgs

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# Option 1 -- application

Example: Higgs to diphoton differential cross sections

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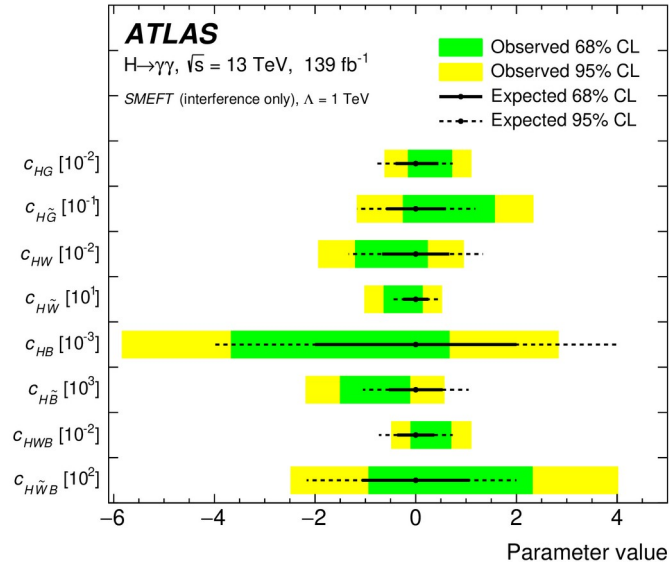
Prediction vector:

Measurement covariance matrix

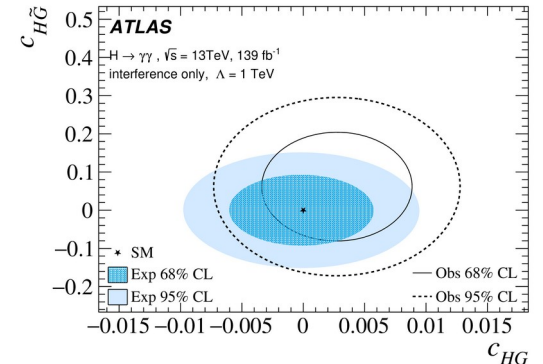
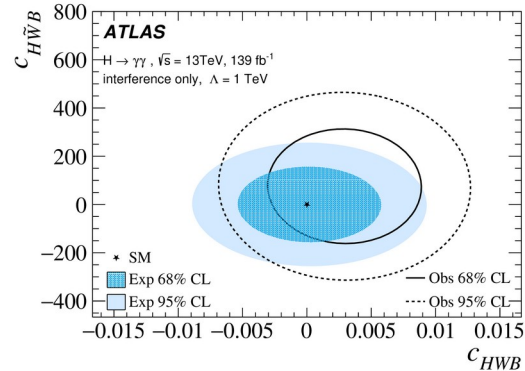
Measurement vector

Results from chi2 minimisation:

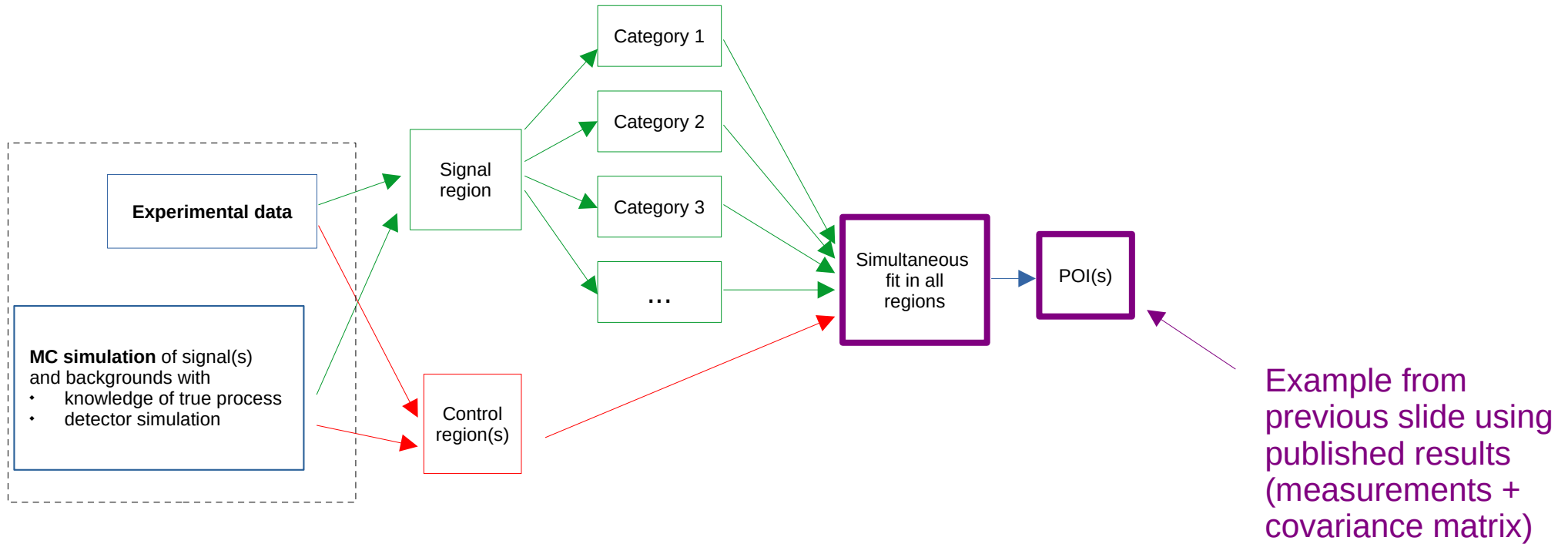
Adding 1 operator at the time



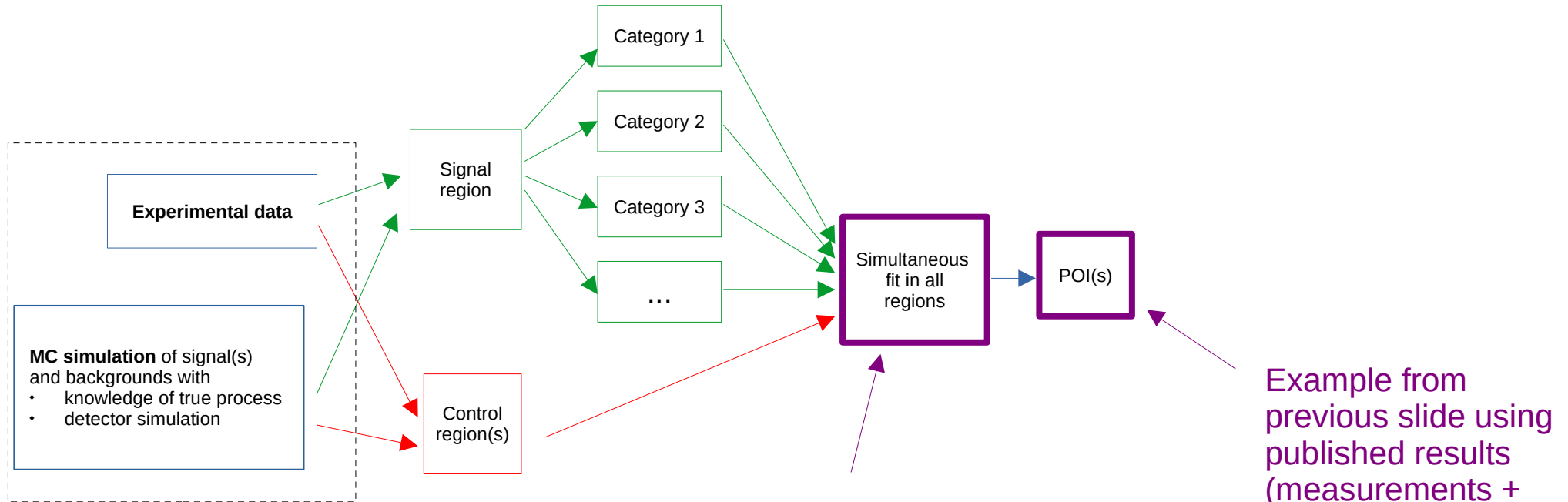
2-dimensional optimisation constraining CP-odd versus CP-even couplings in Higgs decay (left) and production (right)



# Option 1 -- application



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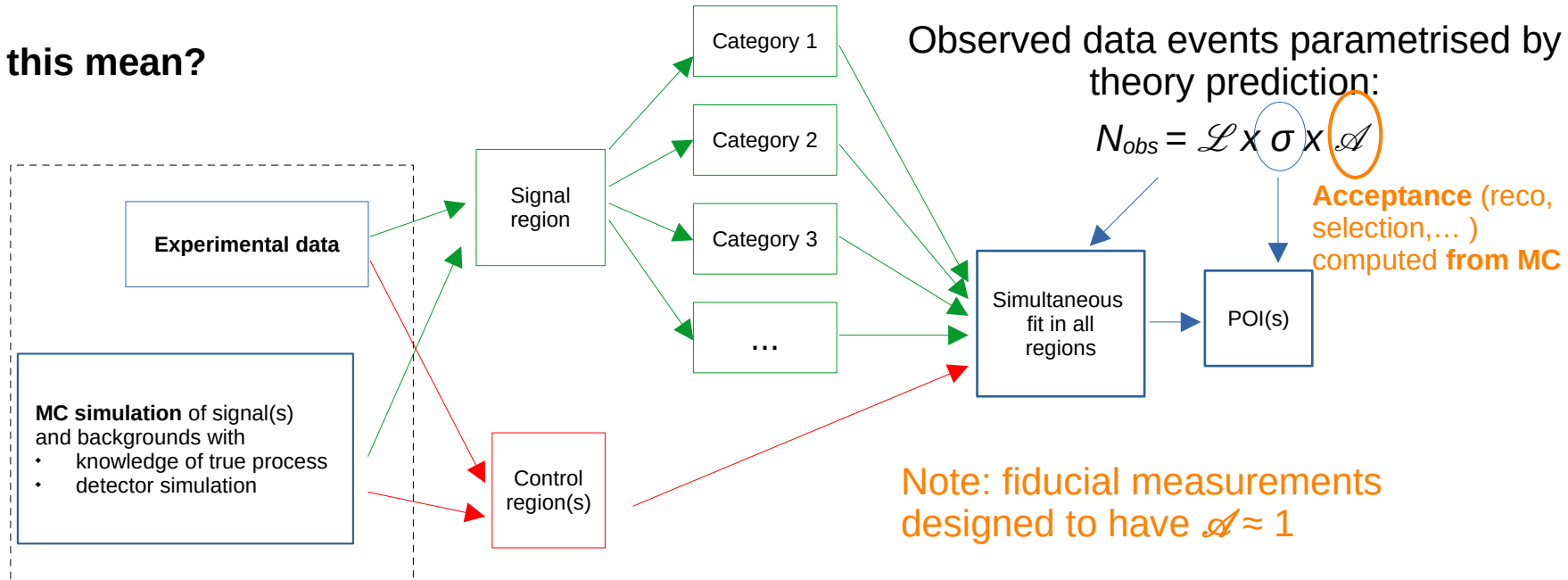
As experimentalist, have the possibility to go one step back and insert **EFT parametrisation into likelihood** (working in very similar way):

- Better treatment of non-Gaussian contributions
- Correlation of systematic uncertainties between measurements
- Correlations between signal and backgrounds

# Option 1 – working with a real detector

- Using experimental data requires reconstruction and event selection – to optimise the sensitivity and reject backgrounds, specific phase spaces are selected by analysis cuts
- Analysis strategy should be independent on input model – in many analyses, phase space extrapolations are made using acceptance calculations based on SM samples

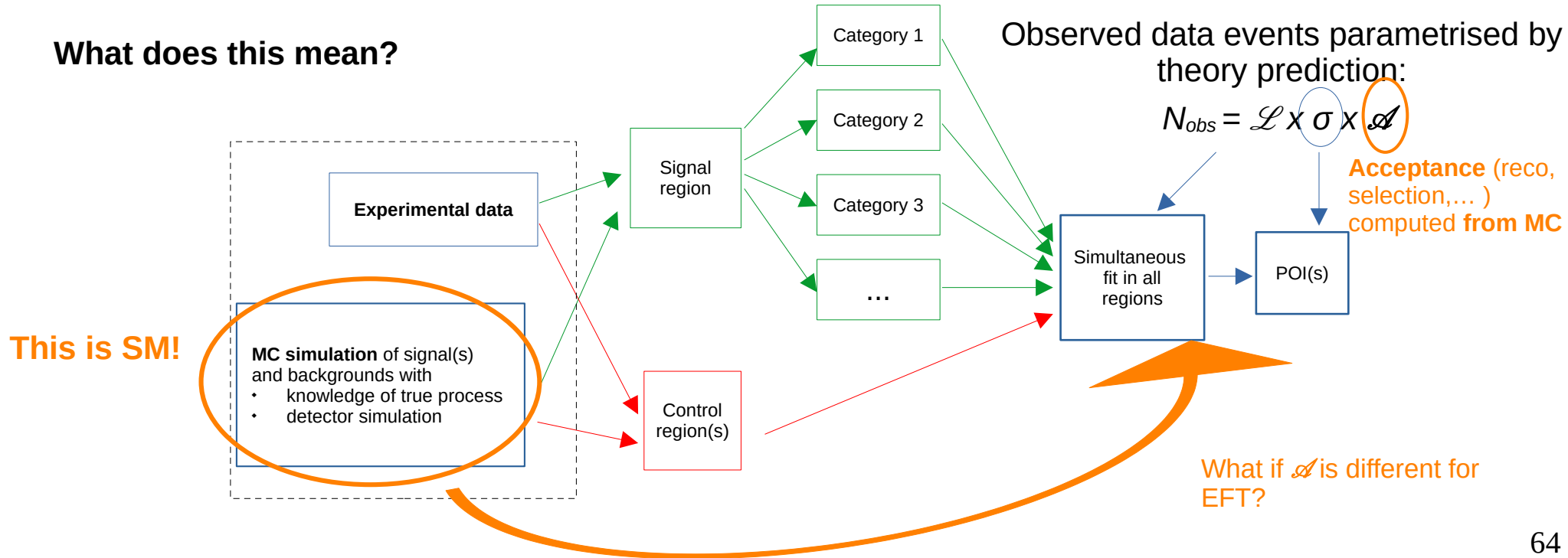
## What does this mean?



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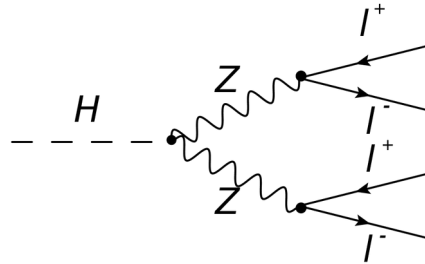


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## Example: $H \rightarrow ZZ^* \rightarrow 4l$ measurement

- Final state with 2 lepton pairs ( $e^+e^-$  or  $\mu^+\mu^-$ )
- Selection of Higgs based on dilepton mass:
  - Leading pair from Z:  $50 < m_{12} < 106$  GeV
  - Subleading pair from off-shell Z:  $m_{\min} < m_{34} < 115$  GeV ( $12 < m_{\min} < 50$  GeV)

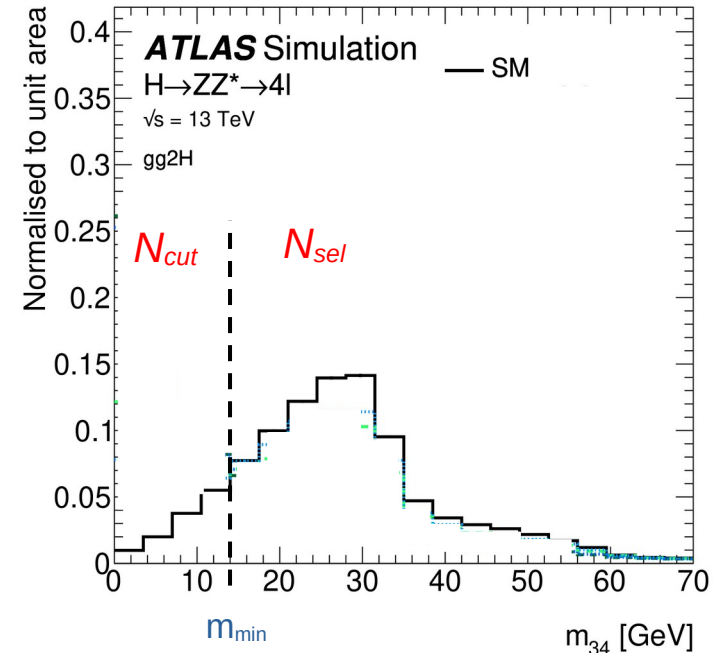


$$N_{obs}^i = \mathcal{L} \times \sigma^i \times \underbrace{BR(H \rightarrow ZZ^*)}_{\text{POI}} \times \mathcal{A}$$

Selected data events in given  $p_T^H$  bin  $i$       Integrated luminosity      POI      Acceptance factor

$$\mathcal{A} = \frac{N_{sel}}{(N_{sel} + N_{cut})}$$

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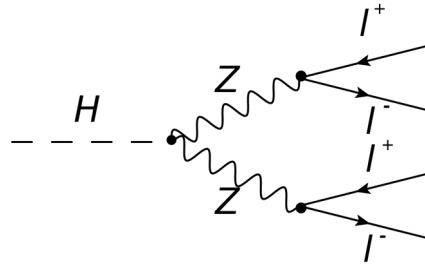


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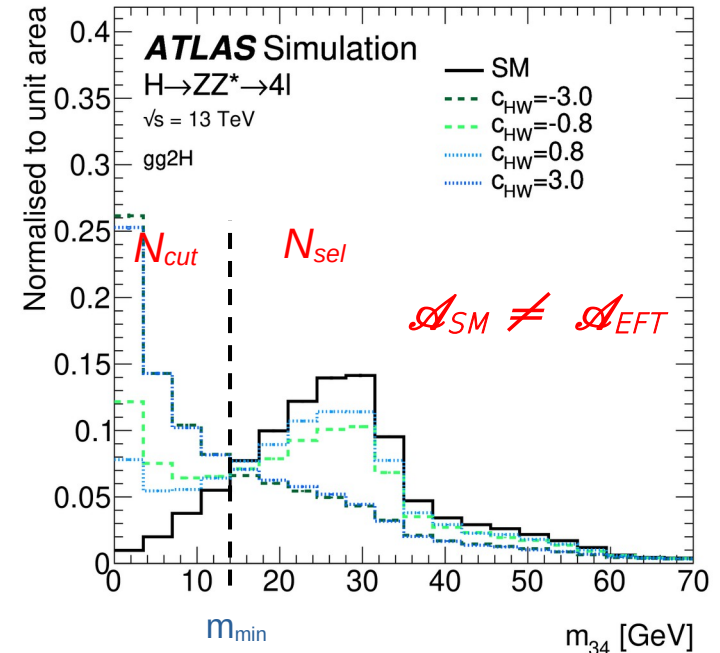


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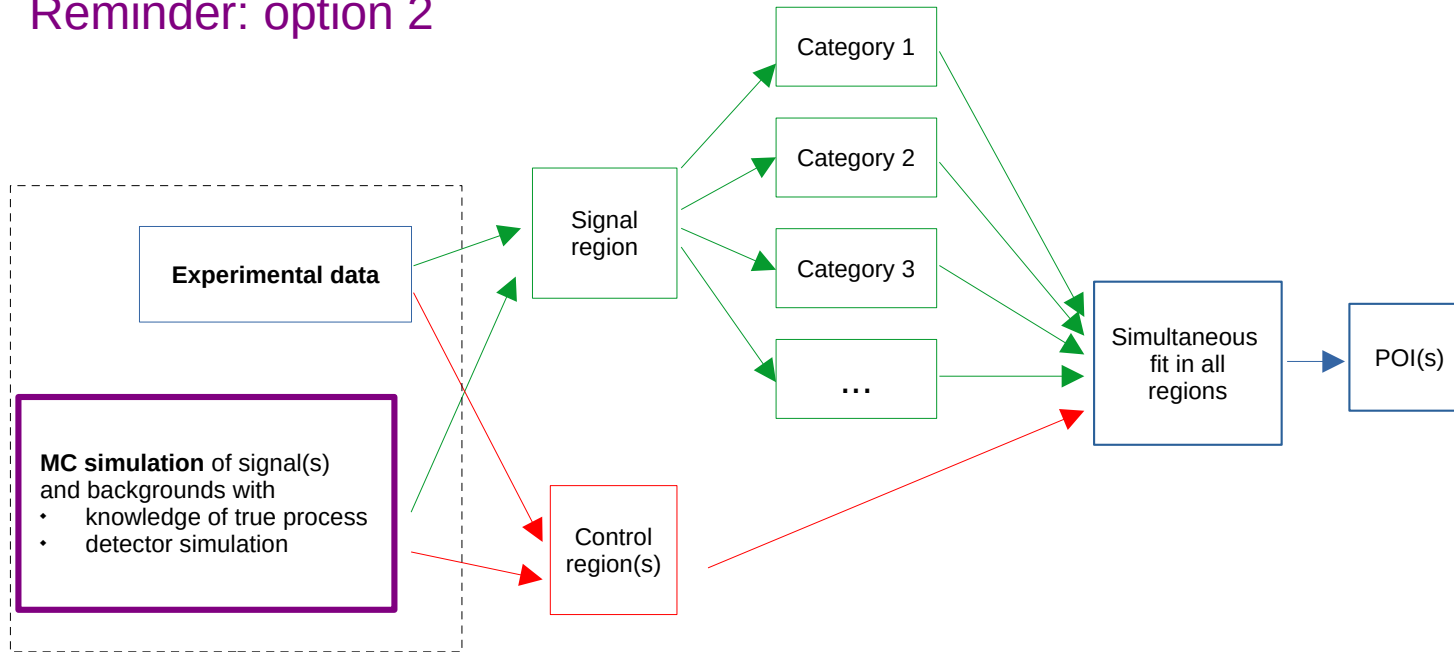


# Option 1 – working with a real detector

- › One solution: fiducial measurements  $\leftrightarrow$  measure cross section in phase space close to analysis selection
- › Else, possibility to overcome acceptance effects using explicit parametrisation as a function of Wilson coefficients
  - ◆ Parametrisation with “arbitrary” function – working well for small deviations of  $c_i$  (within EFT validity)
  - ◆ Can become heavy if taking into account many operators and quadratic terms
  - ◆ Analysis design might be suboptimal for sensitivity to EFT operators (e.g. cutting away phase space with large EFT effects)

# Building the EFT parametrisation

## Reminder: option 2

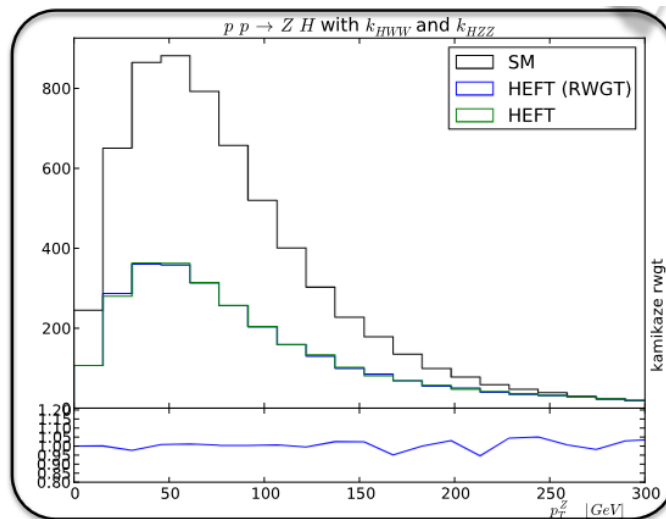
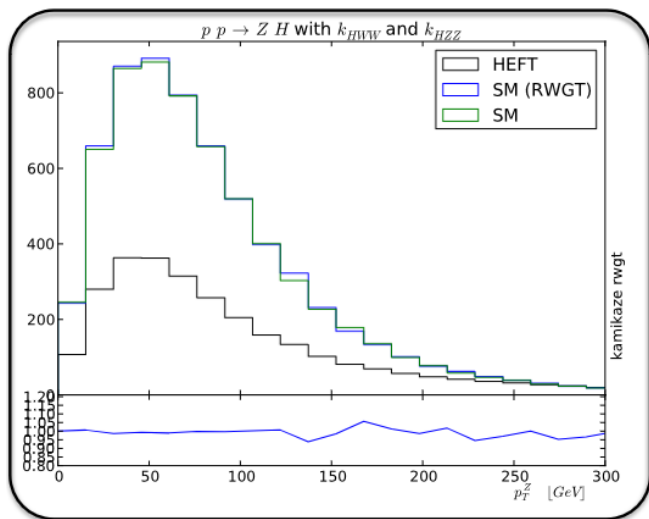


Full analysis chain performed (or at least cross checked) using EFT samples with different values of Wilson coefficients

- Automatically taking into account acceptance effects
- Possibility to optimise analysis towards EFT sensitivity

# Option 2 – MC production

- Requiring full simulation (ME, PS & detector) for many values of each Wilson coefficients → very heavy
- Solution: reweighting
  - Generate one high statistics sample
  - Reweight events at truth level (matrix element ratios) to EFT predictions for several values of different Wilson coefficient (combinations)
  - Only need to run parton shower + detector simulation ones for these events
  - Initial samples should cover the same (or larger) phase space than alternative models
  - Need many events to avoid large statistical uncertainties (for weights > 1) and problems due to correlations

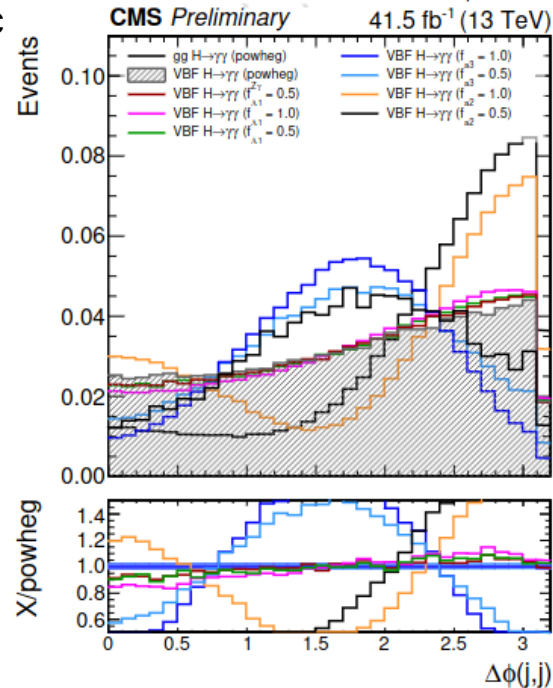


O. Mattelaer  
(<https://indico.cern.ch/event/458670/#4-mc-ac-reweighting-and-nlo-ew>)

# Option 2 -- EFT optimised analyses

- Possibility to build analysis for optimal EFT sensitivity
  - ◆ Categorisation to target specific couplings
  - ◆ Design of observables with good separation of model hypothesis (“simple” kinematic observables, matrix element approximations, machine learning techniques... )

Example 1: kinematic variable sensitive to Higgs CP nature



Example 2: Matrix Element Likelihood Approach

$$\mathcal{D}_{\text{alt}}(\Omega) = \frac{\mathcal{P}_{\text{sig}}(\Omega)}{\mathcal{P}_{\text{sig}}(\Omega) + \mathcal{P}_{\text{alt}}(\Omega)}$$

$$\mathcal{D}_{\text{int}}(\Omega) = \frac{\mathcal{P}_{\text{int}}(\Omega)}{2 \sqrt{\mathcal{P}_{\text{sig}}(\Omega) \mathcal{P}_{\text{alt}}(\Omega)}}$$

- ◆ “sig”: SM Higgs signal (possibly specific production mode)
- ◆ “alt”: background, production modes or BSM
- ◆ “int”: interference terms
- ◆  $\Omega$ : full kinematic description of process

# Option 2 – limitations

- Perform analysis for discrete values of  $c_i$ ; to fit these on data, need fine granularity or some interpolation (morphing)
  - Feasible for linear terms, varying 1 Wilson coefficient at the time
  - Becoming very difficult when including quadratic terms (with interference between different operators)
- Optimised analysis working well in case of a few, well defined operators impacting analysed process – not suited for global EFT fit
- Detailed analysis examples in dedicated lectures (flavour + Higgs / EW physics)

# Building the EFT parametrisation

## Option 1

- Simple approach – re-parametrisation of analysis results
- Fast to simulate – only require truth level simulation for a few Wilson coefficients values
- Might compromise on sensitivity due to non-optimised analysis regarding EFT effects
- Might require separate (ad-hoc) parametrisation of EFT acceptance compared to SM acceptance – can introduce large uncertainties or biases
- Often assume SM backgrounds or analysis results assumed to be uncorrelated to background modelling

## Option 2

- Full consideration of EFT effects in analysis design to obtain optimal sensitivity
- Automatically taking into account acceptance effects
- Heavy simulation (at detector level), limiting number of considered operators – partially solved using ME reweighting
- Need interpolation between simulated points – difficult to treat quadratic terms (interference between EFT operators)
- Potentially more complicated to treat interplay between signal and backgrounds



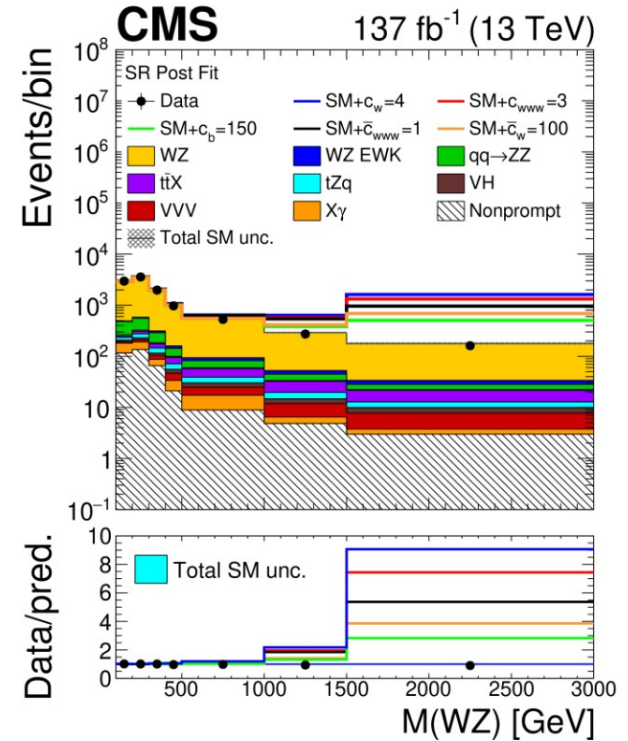
# Making physics with EFT

- › Up to now, have measured some physics quantities and re-parametrised in terms of EFT – on a very technical basis...
- › Main goal: learn something about physics!
- › Need to ask several questions:
  - ◆ What is the BSM scale that we are sensitive to? Is the EFT approach valid in the regime we are probing? ↔ choice of new physics scale  $\Lambda$
  - ◆ Which EFT operators should be considered? How do we treat correlations between them? ↔ choice of fit parameters – more details in global EFT fit discussion
  - ◆ What do these results tell us in terms of “real” physics models?

# Choice of BSM scale $\Lambda$

- Main assumption in EFT formalism:  $c/\Lambda^2 \ll 1 \rightarrow$  naively, best to consider higher scale & small coupling
- Often  $\Lambda=1\text{TeV}$ ; historical choice from flavour physics (studying meson decays with low  $q^2 \sim 10 \text{ GeV}^2$ )
- Larger impact from BSM at “not so large” scale  $\rightarrow$  better sensitivity
- But often, high energy tails most affected by EFT; containing events with high  $q^2$

Example: WZ production @ LHC



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# Content

- Ingredients for EFT fits
  - ❖ Input measurements – experiments, observables, etc.
- EFT constraints from experimental data
  - ❖ Setup: model, basis, input parameters, symmetries
  - ❖ EFT in the analysis: simulation and parametrisation
  - ❖ Working with a real detector
  - ❖ Validity considerations and theory uncertainties: limitations and work arounds
- **Global EFT fits**
  - ❖ **Benefits and challenges of combined fit**
  - ❖ **Limitations and perspectives for EFT fits – towards HL-LHC and beyond**

Note: This lecture is quite technical; more details on application of these concepts in dedicated sessions (EFT in Higgs + EW and in flavour physics)

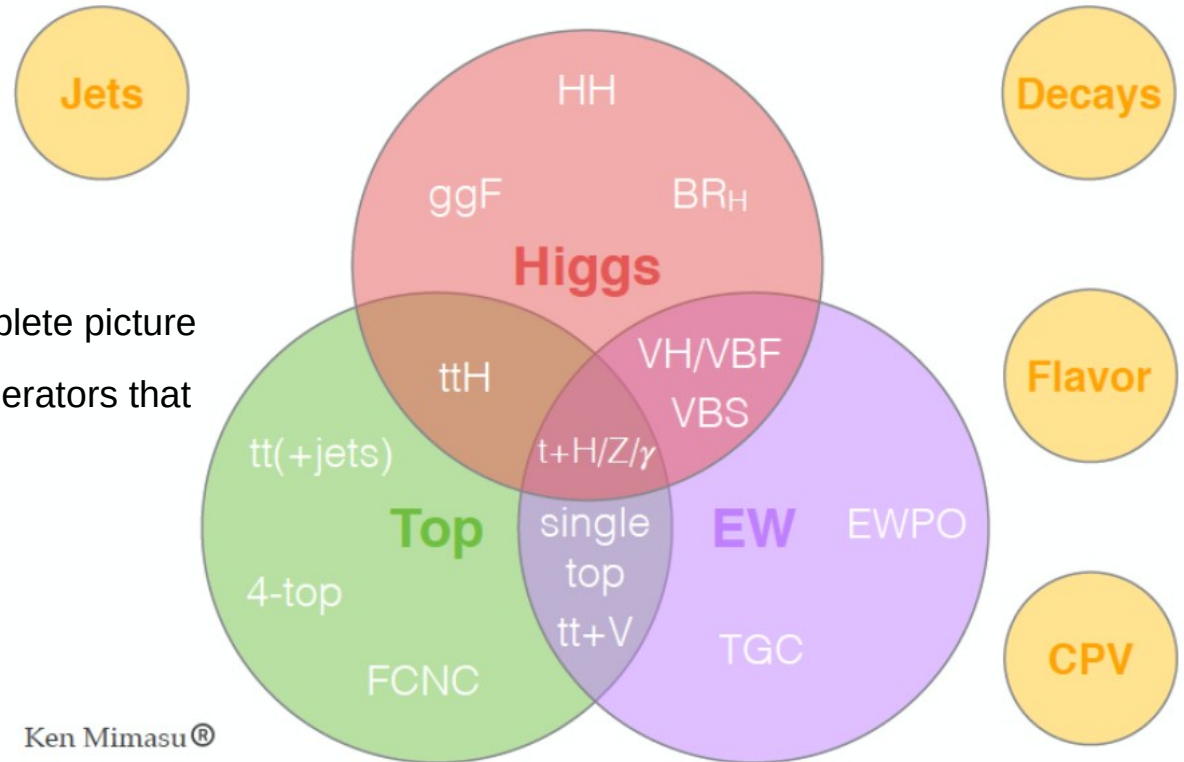
# Why doing a global fit?

BSM can be in several EFT operators at the same time

→ should fit simultaneously all EFT operators to ensure model-independence

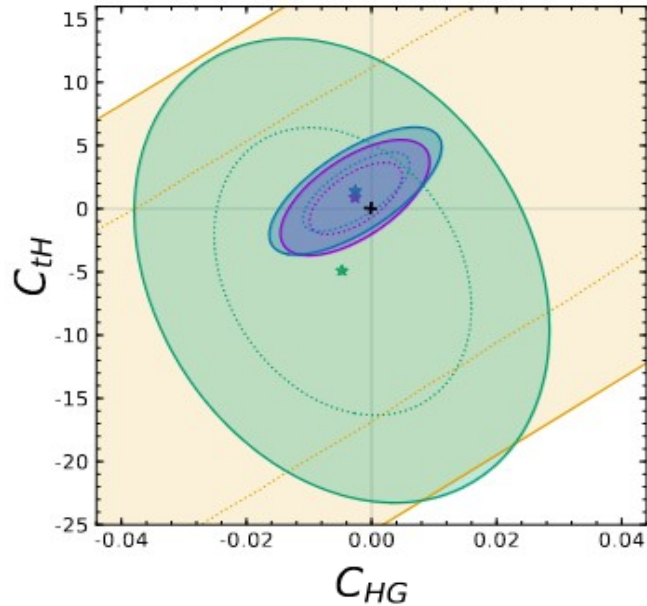
Use complementarity of physics processes:

- sensitive to different EFT operators – get complete picture
- overlapping couplings – help to decorrelate operators that affect single processes in a similar way



# Decorrelating operators through combination

Example:

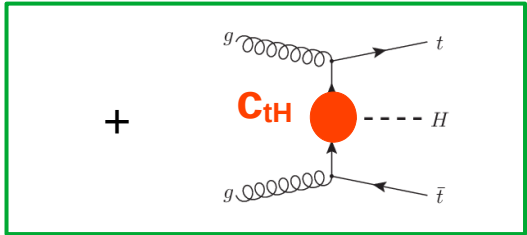
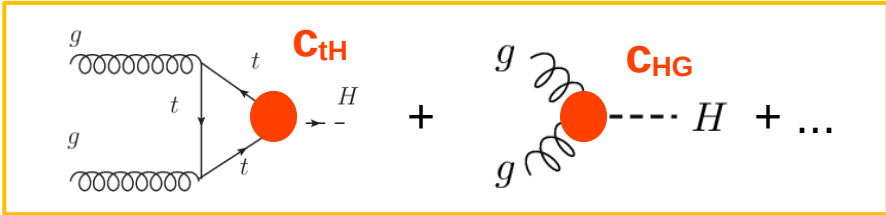


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$C_{tH}$ : top Yukawa coupling modifier

$C_{HG}$ : effective Higgs-gluon coupling

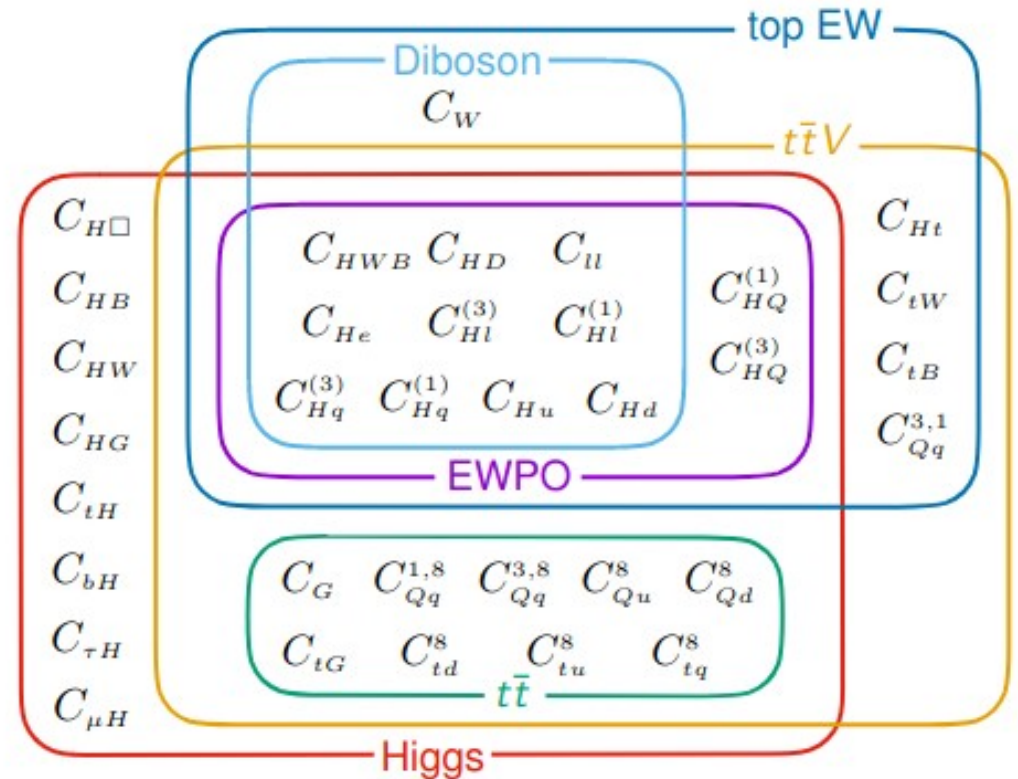
- Marginalised 95% C. L.
- Higgs data (no  $t\bar{t}H$ )
  - Higgs data
  - Higgs & Top data
  - Higgs & Top data (+4F)
  - + SM



# Global EFT fit – a broad picture

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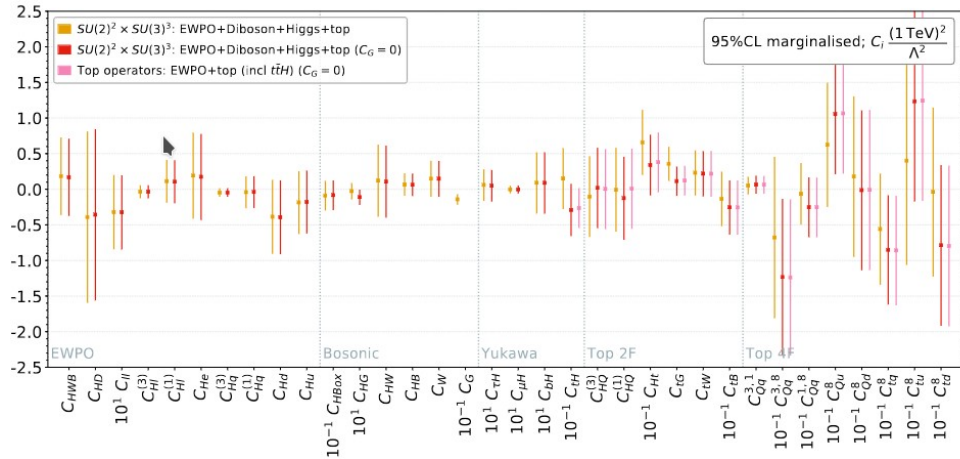
- Input: as many as possible orthogonal measurements from different experiments:
  - EW precision observables
  - Diboson measurements from LEP & LHC
  - Higgs measurements from LHC Run 1+2
  - Top measurements from Tevatron & LEP
- Good complementarity of analyses to constrain Wilson coefficients



# Global EFT fit – flat directions

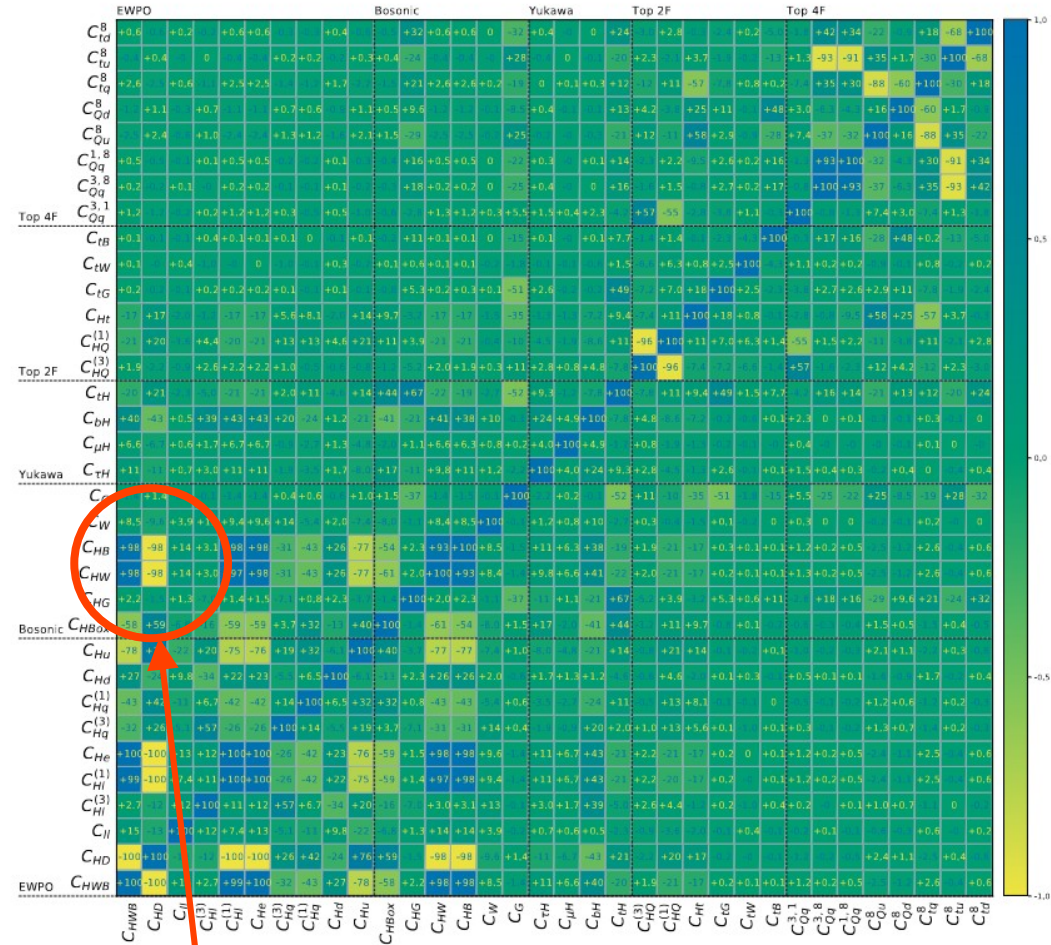
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Constraining a large set of operators simultaneously



Still, large correlations between some operators: so-called flat directions, where we are only sensitive to linear combinations of several operators

Solution: principle component analysis -- more details in Higgs+EW lecture



Example: these  $C_{HB}$  and  $C_{HW}$  are only constrained from bosonic Higgs couplings

# Reasons to do global EFT fit within experiments

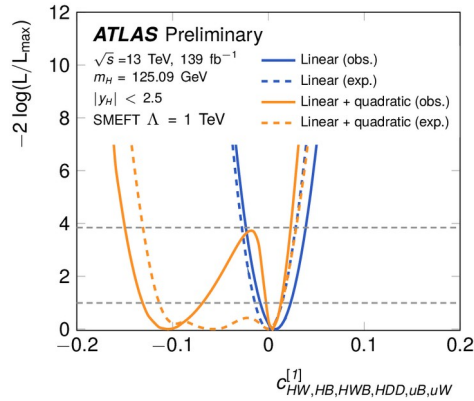
- Correlation of measured signal with background processes
  - ◆ Usually assume background to be SM-like in EFT fits -- might be affected by BSM as well
  - ◆ Signal and background measurements might be correlated (e.g.  $VH \rightarrow llbb$ , dominant systematics from background modeling)
- Orthogonality between analyses
  - ◆ Several analyses can target overlapping signal, i.e. same signal but optimised for different measurement, or one analysis is subset of the other
  - ◆ Backgrounds of one analysis might be signals of another analysis
  - ◆ Can be avoided at experiment level from beginning on or statistical correlations can be inferred through bootstrapping
  - ◆ Might happen at the price of sensitivity – choice to be made
- Proper correlation of systematic uncertainties between analyses (e.g. jet energy scale calibration is the same in all analyses containing jets)



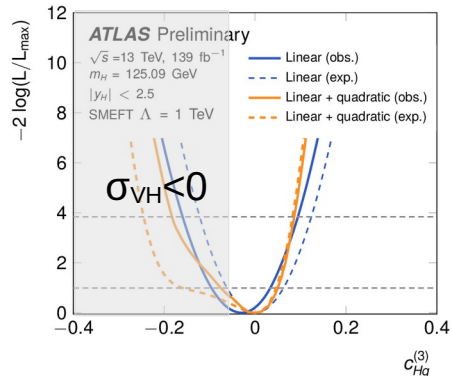
# EFT limitations and uncertainties

Quadratic terms can be important; interpretation?

→ also check linear dim-8 -- same order in  $1/\Lambda^2$



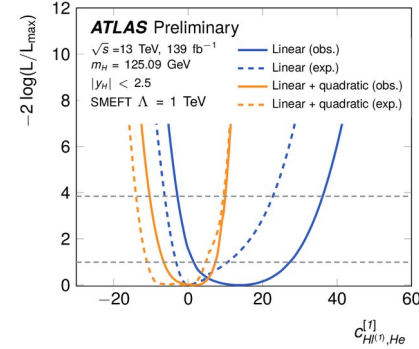
Linear-only parametrisation might lead to unphysical, negative cross section predictions



Which operators can be safely ignored?

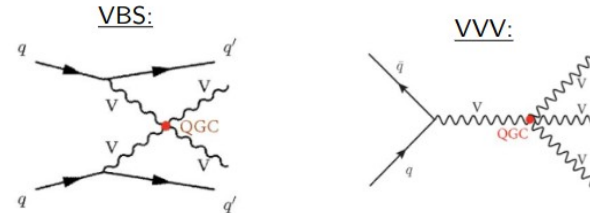
→  $1\sigma$  bound can be far outside valid range

→ significant correlation to other, thus can not be ignored



Some BSM occurring at dim-8, e.g. aQGC

→ how to make consistent interpretation in global fit?



Huge effort going on in theory + experiment to solve these problems, calculate uncertainties, etc.

# Conclusion

- › EFT interpretations becoming more and more important at LHC and beyond
- › Allow to search for new physics in model independent way
  - ◆ Including constraints from all fields
  - ◆ Without probing a concrete model – (mostly) any model can be matched to EFT results
- › Active field – many ongoing developments (both from theory and experiment)
  - ◆ A lot of exchange ongoing to optimise and synchronise efforts to learn as much as possible from the available data
  - ◆ Some unsolved limitations – need to find solutions and sometimes be pragmatic

THANKS FOR YOUR ATTENTION

BACKUP

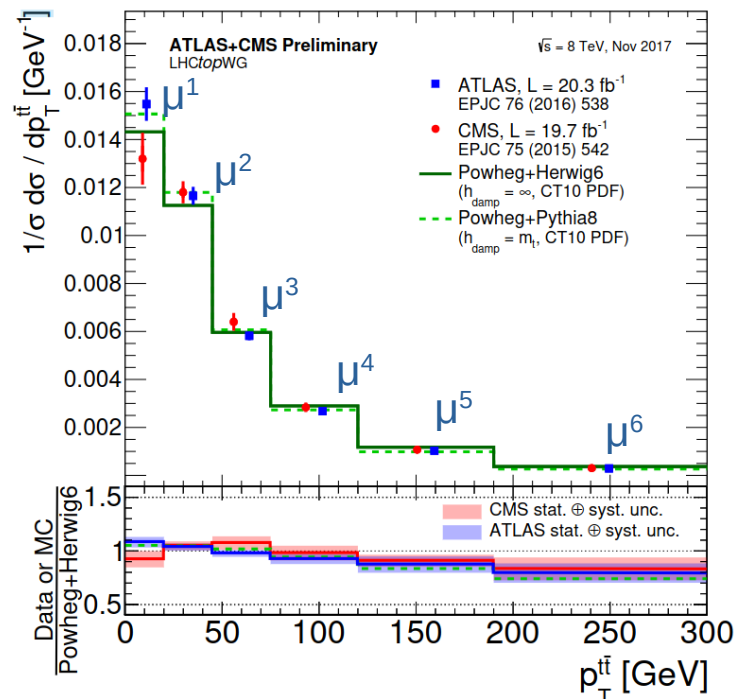
# Option 1 -- application

## Example: ttbar production @ LHC

### Input measurement:

Differential cross section as a function of  $p_{T^{\text{tt}}}$  of ttbar system

- cross section in each  $p_{T^{\text{tt}}}$  bin (+ uncertainty)
- possible correlation between bins



$$\chi^2 = (P-\mu) C^{-1} (P-\mu)^T$$

Measurement covariance matrix

Measurement vector

Prediction vector:

$$P^i = \sigma_{ttbar}^i \times \left( 1 + \sum_i A_i c_i + \sum_{ij} B_{ij} c_i c_j \right)$$

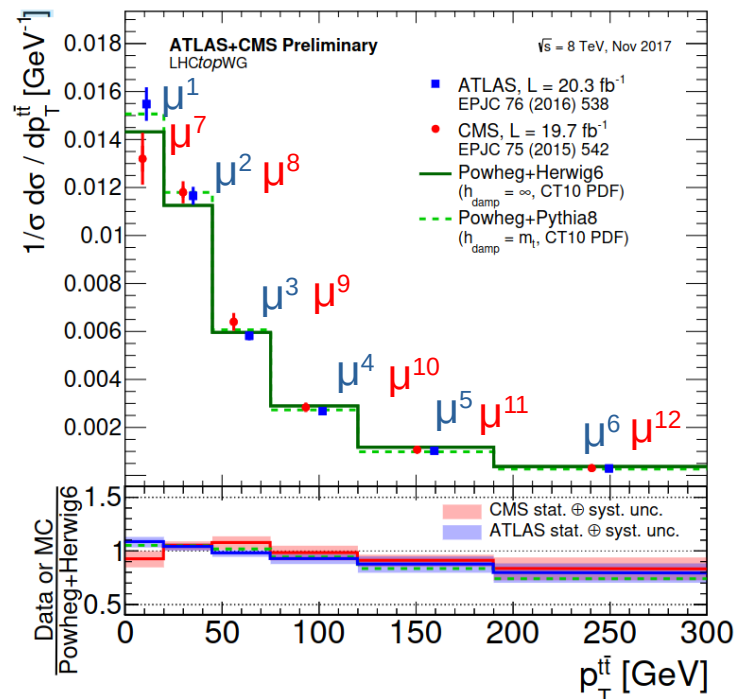
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Measurement vector

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Straight forward to combine, e.g., ATLAS & CMS results, assuming no correlation between experiments / measurements